

ATT3000 Series Field-Programmable Gate Arrays

FEATURES

- High Performance—up to 150 MHz Toggle Rates
- User-Programmable Gate Array
 - I/O functions
 - Digital logic functions
 - Interconnections
- Flexible array architecture
 - Compatible arrays, 2000 to 9000 gate logic complexity
 - Extensive register and I/O capabilities
 - High fan-out signal distribution
 - Internal three-state bus capabilities
 - TTL or CMOS input thresholds
 - On-chip oscillator amplifier
- Standard product availability
 - Low power, CMOS, static memory technology
 - Pin-for-Pin to *Xilinx* XC3000 Family
 - 100% factory pre-tested
 - Selectable configuration modes
- Complete *XACT* development system
 - Schematic Capture
 - Automatic Place/Route
 - Logic and Timing Simulation
 - Design Editor
 - Library and User Macros
 - Timing Calculator
 - Standard PROM File Interface

DESCRIPTION

The CMOS ATT3000 series Field-Programmable Gate Array (FPGA) family provides a group of high-performance, high-density, digital, integrated circuits. Their regular, extendable, flexible, user-programmable array architecture is composed of a configuration program store plus three types of configurable elements: a perimeter of I/O Blocks, a core array of Logic Blocks and resources for interconnection. The general structure of a FPGA is shown in Figure 1 on the next page. The *XACT* development system provides schematic capture and auto place-and-route for design entry. Logic and timing simulation, and in-circuit emulation are available as design verification alternatives. The de-

sign editor is used for interactive design optimization, and to compile the data pattern which represents the configuration program.

The FPGA's user logic functions and interconnections are determined by the configuration program data stored in internal static memory cells. The program can be loaded in any of several modes to accommodate various system requirements. The program data resides externally in an EEPROM, EPROM or ROM on the application circuit board, or on a floppy disk or hard disk. On-chip initialization logic provides for optional automatic loading of program data at power-up. A serial configuration PROM can provide a very simple serial configuration program storage.

| Basic Array | Logic Capacity (usable gates) | Configurable Logic Blocks | User I/Os | Program Data (bits) |
|-------------|-------------------------------|---------------------------|-----------|---------------------|
| ATT3020 | 2000 | 64 | 64 | 14779 |
| ATT3030 | 3000 | 100 | 80 | 22176 |
| ATT3042 | 4200 | 144 | 96 | 30784 |
| ATT3064 | 6400 | 224 | 120 | 46064 |
| ATT3090 | 9000 | 320 | 144 | 64160 |

The ATT3000 series FPGAs are an enhanced family of Field Programmable Gate Arrays, which provide a variety of logic capacities, package styles, temperature ranges and speed grades.

ARCHITECTURE

The perimeter of configurable I/O Blocks (IOBs) provides a programmable interface between the internal logic array and the device package pins. The array of Configurable Logic Blocks (CLBs) performs user-specified logic functions. The interconnect resources are programmed to form networks, carrying logic signals among blocks, analogous to printed circuit board traces connecting MSI/SSI packages.

The blocks' logic functions are implemented by programmed look-up tables. Functional options are implemented by program-controlled multiplexers. Interconnecting networks between blocks are implemented with metal segments joined by program-controlled pass transistors. These functions of the FPGA are established by a configuration program which is loaded into an internal, distributed array of configuration memory cells. The configuration program is loaded into the FPGA at power-up and may be reloaded on command. The FPGA includes logic and control signals to implement automatic or passive configuration. Program data may be either bit serial or byte parallel. The XACT development system generates the configuration program bit-stream used to configure the FPGA. The memory loading process is independent of the user logic functions.

CONFIGURATION MEMORY

The static memory cell used for the configuration memory in the FPGA has been designed specifically for high reliability and noise immunity. Integrity of the FPGA configuration memory based on this design is assured even under various adverse conditions. Com-

pared with other programming alternatives, static memory is believed to provide the best combination of high density, high performance, high reliability and comprehensive testability. As shown in Figure 2, the basic memory cell consists of two CMOS inverters plus a pass transistor used for writing and reading cell data. The cell is only written during configuration and only read during readback. During normal operation the cell provides continuous control and the pass transistor is "off" and does not affect cell stability. This is quite different from the operation of conventional memory devices, in which the cells are frequently read and re-written.

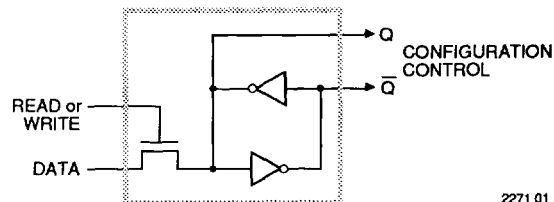


Figure 2. A static configuration memory cell is loaded with one bit of configuration program and controls one program selection in the FPGA.

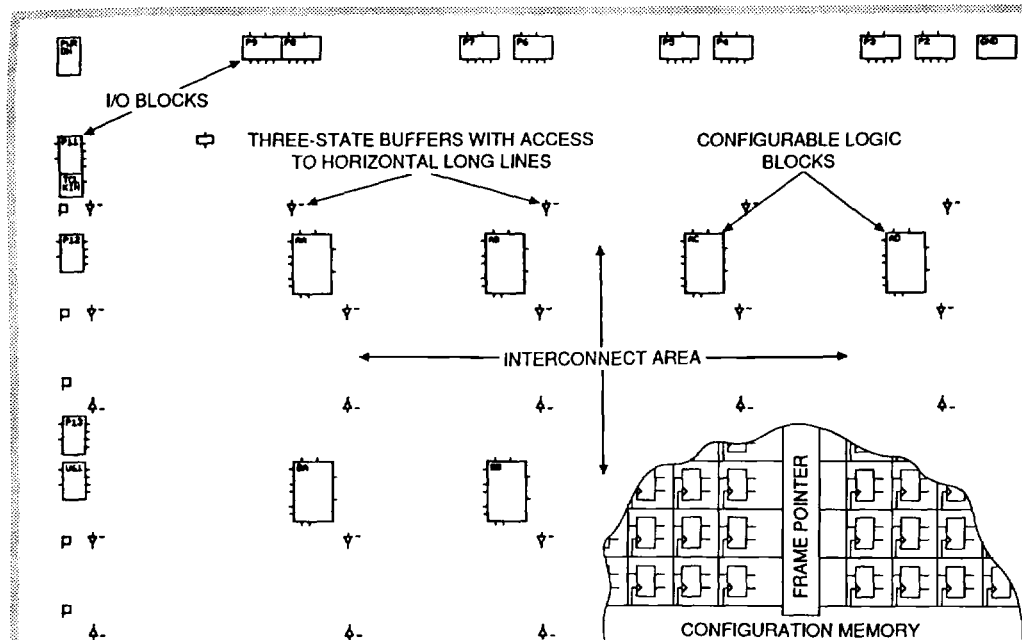


Figure 1. The structure of the Field-Programmable Gate Array consists of a perimeter of programmable I/O blocks, a core of configurable logic blocks and their interconnect resources. These are all controlled by the distributed array of configuration program memory cells.

vides input clamping diodes to provide electro-static protection, and circuits to inhibit latch-up produced by input currents.

The input buffer portion of each I/O Block provides threshold detection to translate external signals applied to the package pin to internal logic levels. The global input-buffer threshold of the I/O Blocks can be programmed to be compatible with either TTL or CMOS levels. The buffered input signal drives the data input of a storage element which may be configured as a positive edge-triggered "D" flip-flop or a low level-transparent latch. The sense of the clock can be inverted (negative edge/high transparent) as long as all IOBs on the same clock net use the same clock sense. Clock/load signals (I/O Block pins *.ik* and *.ok*) can be selected from either of two die edge metal lines. I/O storage elements are reset during configuration or by the active low chip RESET input. Both direct input [from I/O Block pin *.i*] and registered input [from I/O Block pin *.q*] signals are available for interconnect.

For reliable operation inputs should have transition times of less than 100 ns and should not be left floating. Floating CMOS input-pin circuits might be at threshold and produce oscillations. This can produce additional power dissipation and system noise. A typical hysteresis of about 200 mV reduces sensitivity to input noise. Each user I/O Block includes a programmable high impedance pull-up resistor which may be selected by the program to provide a constant HIGH for otherwise undriven package pins. Although the FPGA provides circuitry to provide input protection for electrostatic discharge, normal CMOS handling precautions should be observed.

Flip-flop loop delays for the I/O Block and logic block flip-flops are about 3 nanoseconds. This short delay provides good performance under asynchronous clock and data conditions. Short loop delays minimize the probability of a metastable condition which can result from assertion of the clock during data transitions. Because of the short loop delay characteristic in the FPGA, the I/O Block flip-flops can be used to synchronize external signals applied to the device. Once synchronized in the I/O Block, the signals can be used internally without further consideration of their clock relative timing, except as it applies to the internal logic and routing path delays.

Output buffers of the I/O Blocks provide CMOS-compatible 4 mA source-or-sink drive for high fan-out CMOS or TTL compatible signal levels. The network

driving I/O Block pin *.o* becomes the registered or direct data source for the output buffer. The three-state control signal [I/O Block pin *.f*] can control output activity. An open-drain type output may be obtained by using the same signal for driving the output and three-state signal nets so that the buffer output is enabled only for a LOW.

Configuration program bits for each I/O Block control features such as optional output register, logical signal inversion, and three-state and slew rate control of the output.

The program-controlled memory cells of Figure 3 control the following options:

- Logical **Inversion of the output** is controlled by one configuration program bit per I/O Block.
- Logical **three-state control** of each I/O Block output buffer is determined by the states of configuration program bits which turn the buffer on, or off, or select the output buffer three-state control interconnection [I/O Block pin *.f*]. When this I/O Block output control signal is HIGH, a logic "1", the buffer is **disabled** and the package pin is high impedance. When this I/O block output control signal is LOW, a logic "0", the buffer is **enabled** and the package pin is active. Inversion of the buffer three-state control logic sense (output enable) is controlled by an additional configuration program bit.
- **Direct or registered output** is selectable for each I/O block. The register uses a positive-edge, clocked flip-flop. The clock source may be supplied [I/O Block pin *.ok*] by either of two metal lines available along each die edge. Each of these lines is driven by an invertible buffer.
- Increased **output transition speed** can be selected to improve critical timing. Slower transitions reduce capacitive load peak currents of non-critical outputs and minimize system noise.
- A high impedance **pull-up resistor** may be used to prevent unused inputs from floating.

Summary of I/O Options

- Inputs
 - Direct
 - Flip-flop/latch
 - CMOS/TTL threshold (chip inputs)
 - Pull-up resistor/open circuit

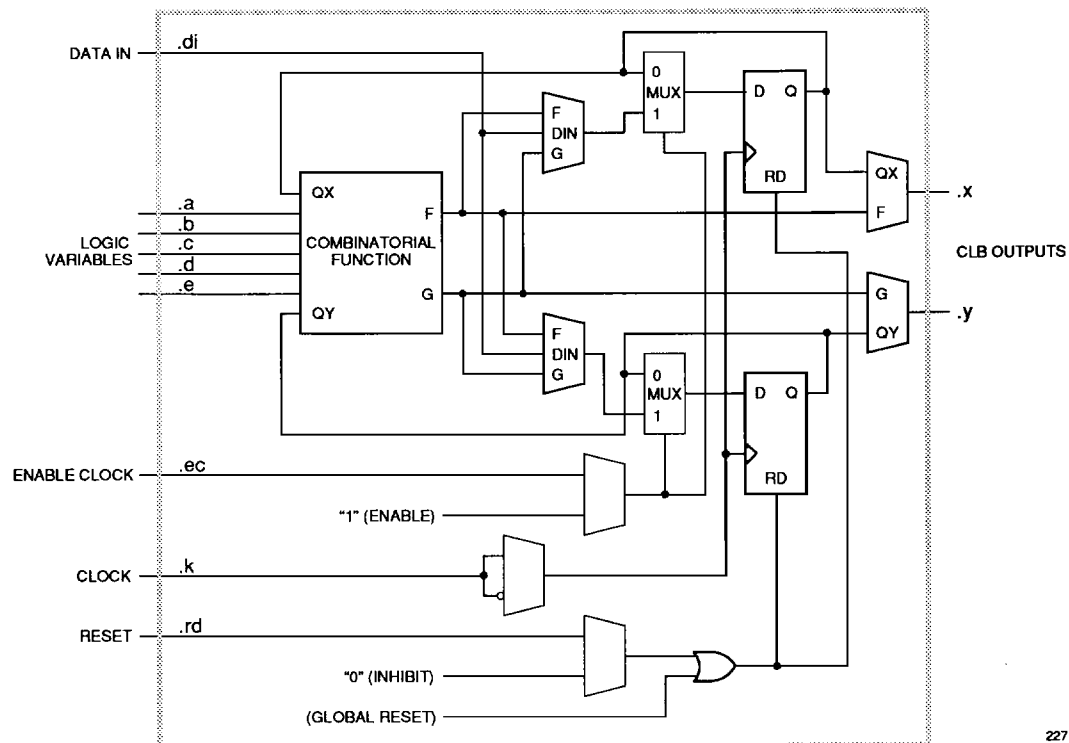
- Outputs
 - Direct/registered
 - Inverted/not
 - Three-state/on/off
 - Full speed/slew limited
 - Three-state/output enable (inverse)

into the internal configuration memory to define the operation and interconnection of each block. User definition of configurable logic blocks and their interconnecting networks may be done by automatic translation from a schematic capture logic diagram or optionally by installing library or user macros.

CONFIGURABLE LOGIC BLOCK

The array of Configurable Logic Blocks (CLBs) provides the functional elements from which the user's logic is constructed. The logic blocks are arranged in a matrix within the perimeter of I/O Blocks. The ATT3020 has 64 such blocks arranged in 8 rows and 8 columns. The XACT development system is used to compile the configuration data which are to be loaded

Each configurable logic block has a combinatorial logic section, two flip-flops, and an internal control section. See Figure 4. There are: five logic inputs [.a, .b, .c, .d and .e]; a common clock input [.k]; an asynchronous direct reset input [.rd]; and an enable clock [.ec]. All may be driven from the interconnect resources adjacent to the blocks. Each CLB also has two outputs [.x and .y] which may drive interconnect networks.



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Figure 4. Each Configurable Logic Block includes a combinatorial logic section, two flip-flops and a program memory controlled multiplexer selection of function.

It has: five logic variable inputs .a, .b, .c, .d and .e.

a direct data in .di

an enable clock .ec

a clock (invertible) .k

an asynchronous reset .rd

two outputs .x and .y

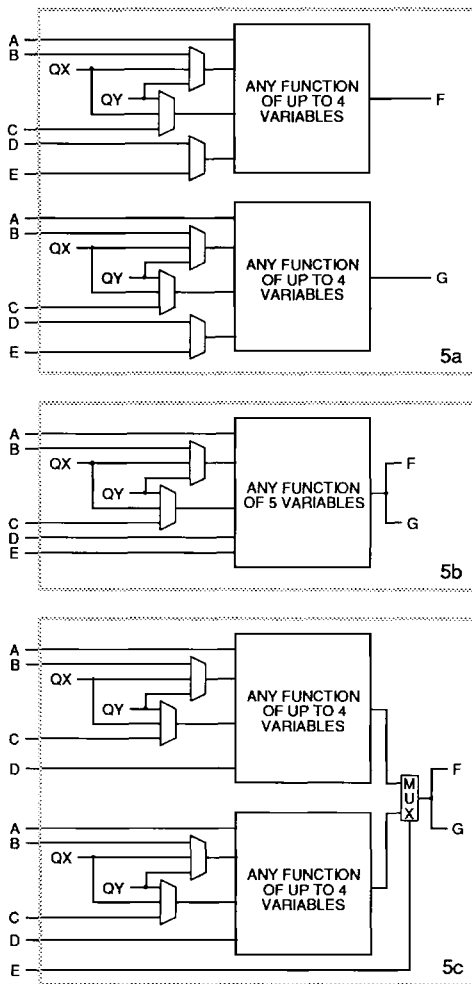
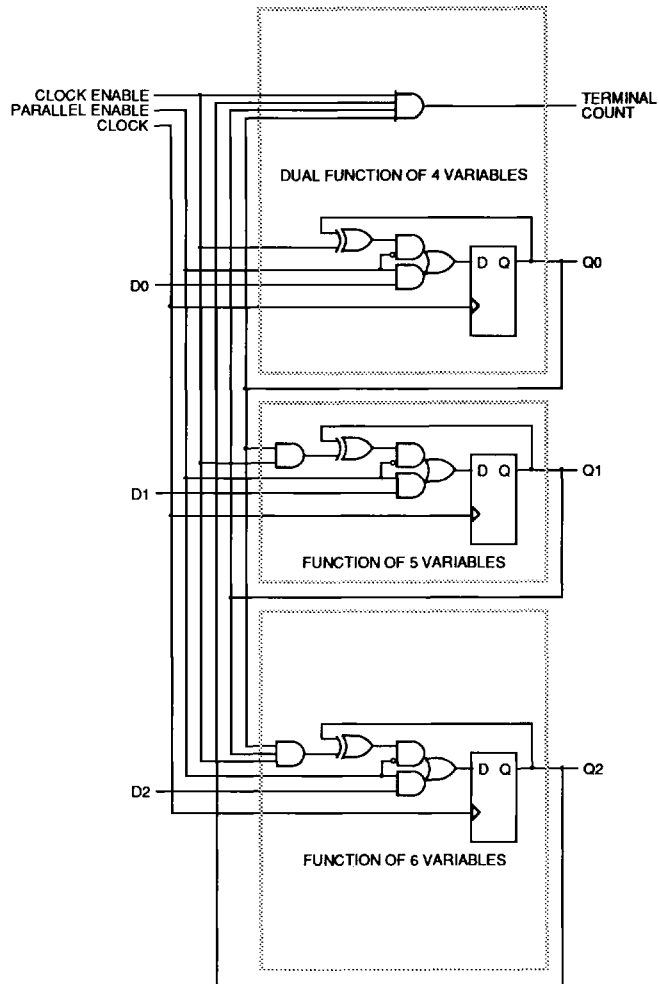


Figure 5

- 5a. Combinatorial Logic Option 1 generates two functions of four variables each. One variable, A, must be common to both functions. The second and third variable can be any choice of B, C, Qx and Qy. The fourth variable can be any choice of D or E.
- 5b. Combinatorial Logic Option 2 generates any function of five variables: A, D, E and and two choices out of B, C, Qx, Qy.
- 5c. Combinatorial Logic Option 3 allows variable E to select between two functions of four variables: Both have common inputs A and D and any choice out of B, C, Qx and Qy for the remaining two variables. Option 3 can then implement some functions of six or seven variables.

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Figure 6. The C8BCP macro (modulo 8 binary counter with parallel enable and clock enable) uses one combinatorial logic block of each option.

Data input for either flip-flop within a CLB is supplied from the function F or G outputs of the combinatorial logic, or the block input, data-in [.d]. Both flip-flops in each CLB share the asynchronous reset [.rd] which, when enabled and HIGH, is dominant over clocked inputs. All flip-flops are reset by the active low chip input, RESET, or during the configuration process. The flip-flops share the enable clock [.ec] which, when LOW, recirculates the flip-flops' present states and inhibits response to the data-in or combinatorial function inputs on a CLB. The user may enable these control inputs and select their sources. The user may also select the clock net input [.k], as well as its active sense within each logic block. This programmable inversion eliminates the need to route both phases of a clock signal throughout the device. Flexible routing allows use of common or individual CLB clocking.

The combinatorial logic portion of the logic block uses a 32 by 1 look-up table to implement Boolean functions. Variables selected from the five logic inputs and two internal block flip-flops are used as table address inputs. The combinatorial propagation delay through the network is independent of the logic function generated and is spike free for single input variable changes. This technique can generate two independent logic functions of up to four variables each as shown in Figure 5a, or a single function of five variables as shown in Figure 5b, or some functions of seven variables as shown in Figure 5c. Figure 6 shows a modulo 8 binary counter with parallel enable. It uses one CLB of each type. The partial functions of six or seven variables are implemented using the input variable [.e] to dynamically select between two functions of four different variables. For the two functions of four variables each, the independent results (F and G) may be used as data inputs to either flip-flop or either logic block output. For the single function of five variables and merged functions of six or seven variables, the F and G outputs are identical. Symmetry of the F and G functions and the flip-flops allows the interchange of CLB outputs to optimize routing efficiencies of the networks interconnecting the logic blocks and I/O Blocks.

PROGRAMMABLE INTERCONNECT

Programmable Interconnection resources in the FPGA provide routing paths to connect inputs and outputs of the I/O and logic blocks into logical networks. Interconnections between blocks are composed from a two-layer grid of metal segments. Specially designed pass transistors, each controlled by a configuration bit, form programmable interconnect points (PIPs) and switching matrices used to implement the necessary

connections between selected metal segments and block pins. Figure 7 is an example of a routed net. The XACT development system provides automatic routing of these interconnections. Interactive routing (Editnet) is also available for design optimization. The inputs of the logic or I/O Blocks are multiplexers which can be programmed to select an input network from the adjacent interconnect segments. **As the switch connections to block inputs are unidirectional (as are block outputs) they are usable only for block input connection and not routing.** Figure 8 illustrates routing access to logic block input variables, control inputs and block outputs. Three types of metal resources are provided to accommodate various network interconnect requirements:

- General Purpose Interconnect
- Direct Connection
- Long Lines (multiplexed busses and wide AND gates)

General Purpose Interconnect

General purpose interconnect, as shown in Figure 9, consists of a grid of five horizontal and five vertical metal segments located between the rows and columns of logic and I/O Blocks. Each segment is the "height" or "width" of a logic block. Switching matrices join the ends of these segments and allow pro-

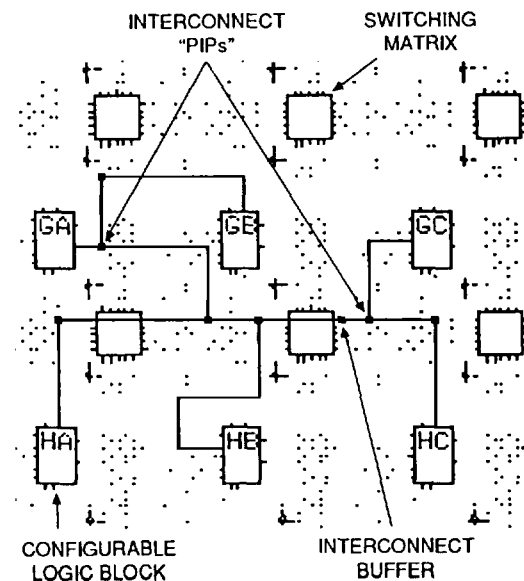


Figure 7. An XACT view of routing resources used to form a typical interconnection network from CLB GA.

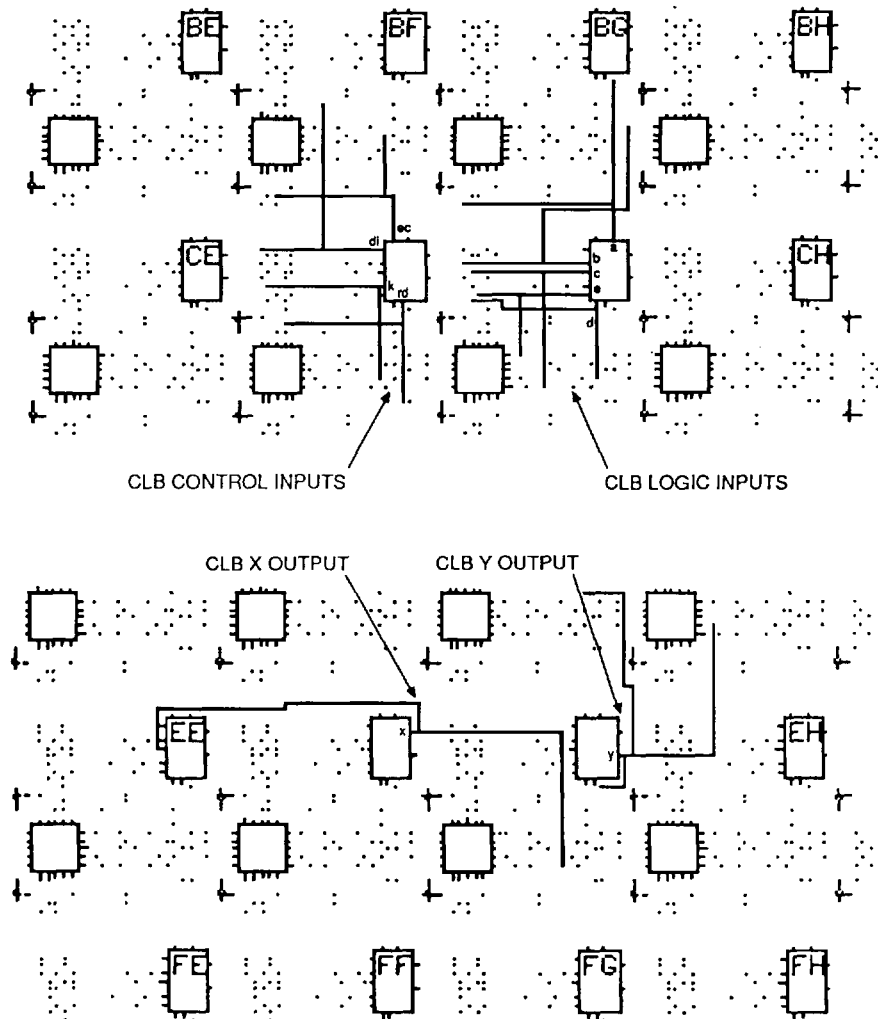


Figure 8. The AT&T XACT Development System view of the locations of interconnect access, CLB control inputs, logic inputs and outputs. The dot pattern represents the available programmable interconnection points (PIPs).

Some of the interconnect "PIPs" are directional. This is indicated on the XACT design editor status line:

- ND is a nondirectional interconnection.
- D:H->V is a PIP which drives from a horizontal to a vertical line.
- D:V->H is a PIP which drives from a vertical to a horizontal line.
- D:C->T is a "T" PIP which drives from a cross of a T to the tail.
- D:CW is a corner PIP which drives in the clockwise direction.
- P0 indicates the PIP is non-conducting, P1 is "on."

grammed interconnections between the metal grid segments of adjoining rows and columns. The switches of an unprogrammed device are all non-conducting. The connections through the switch matrix may be established by the automatic routing or by using "Editnet" to select the desired pairs of matrix pins to be connected or disconnected. The legitimate switching matrix combinations for each pin are indicated in Figure 10 and may be highlighted by the use of the show matrix command in *XACT*.

Special buffers within the general interconnect areas provide periodic signal isolation and restoration for improved performance of lengthy nets. The interconnect buffers are available to propagate signals in either direction on a given general interconnect segment. These bi-directional (bidi) buffers are found adjacent to the switching matrices, above and to the right and may be highlighted by the use of the "Show BIDI" command in *XACT*. The other PIPs adjacent to the matrices are access to or from long lines. The development system automatically defines the buffer direction based on the location of the interconnection network source. The delay calculator of the *XACT* development system automatically calculates and displays the block, interconnect and buffer delays for any paths selected. Generation of the simulation netlist with a worst-case delay model is provided by an *XACT* option.

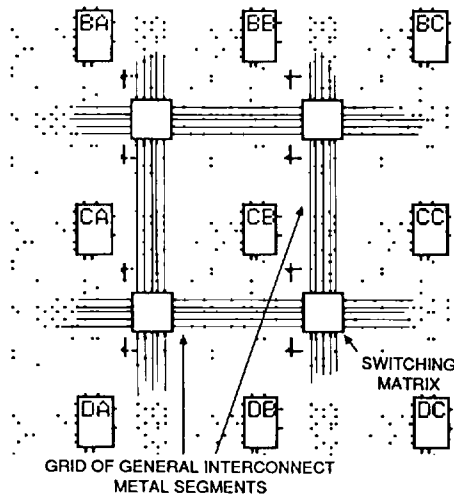


Figure 9. FPGA general-purpose interconnect is composed of a grid of metal segments which may be interconnected through switch matrices to form networks for CLB and I/O block inputs and outputs.

Direct Interconnect

Direct interconnect, shown in Figure 11, provides the most efficient implementation of networks between adjacent logic or I/O Blocks. Signals routed from block to

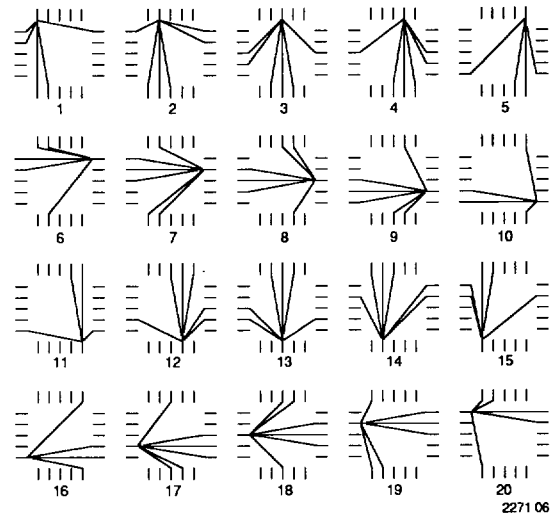


Figure 10. Switch matrix interconnection options for each "pin." Switch matrices on the edges are different. Use "Show Matrix" menu option in *XACT*.

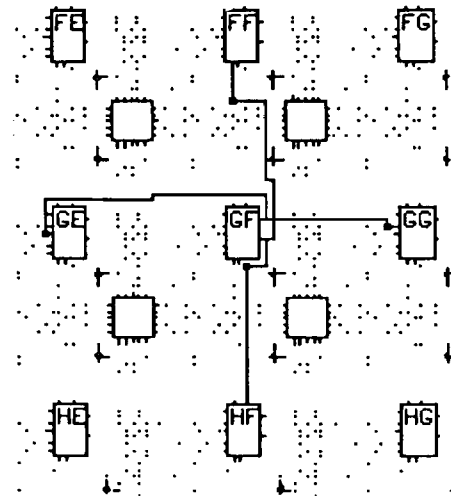


Figure 11. The .x and .y outputs of each CLB have single contact, direct access to inputs of adjacent CLBs.

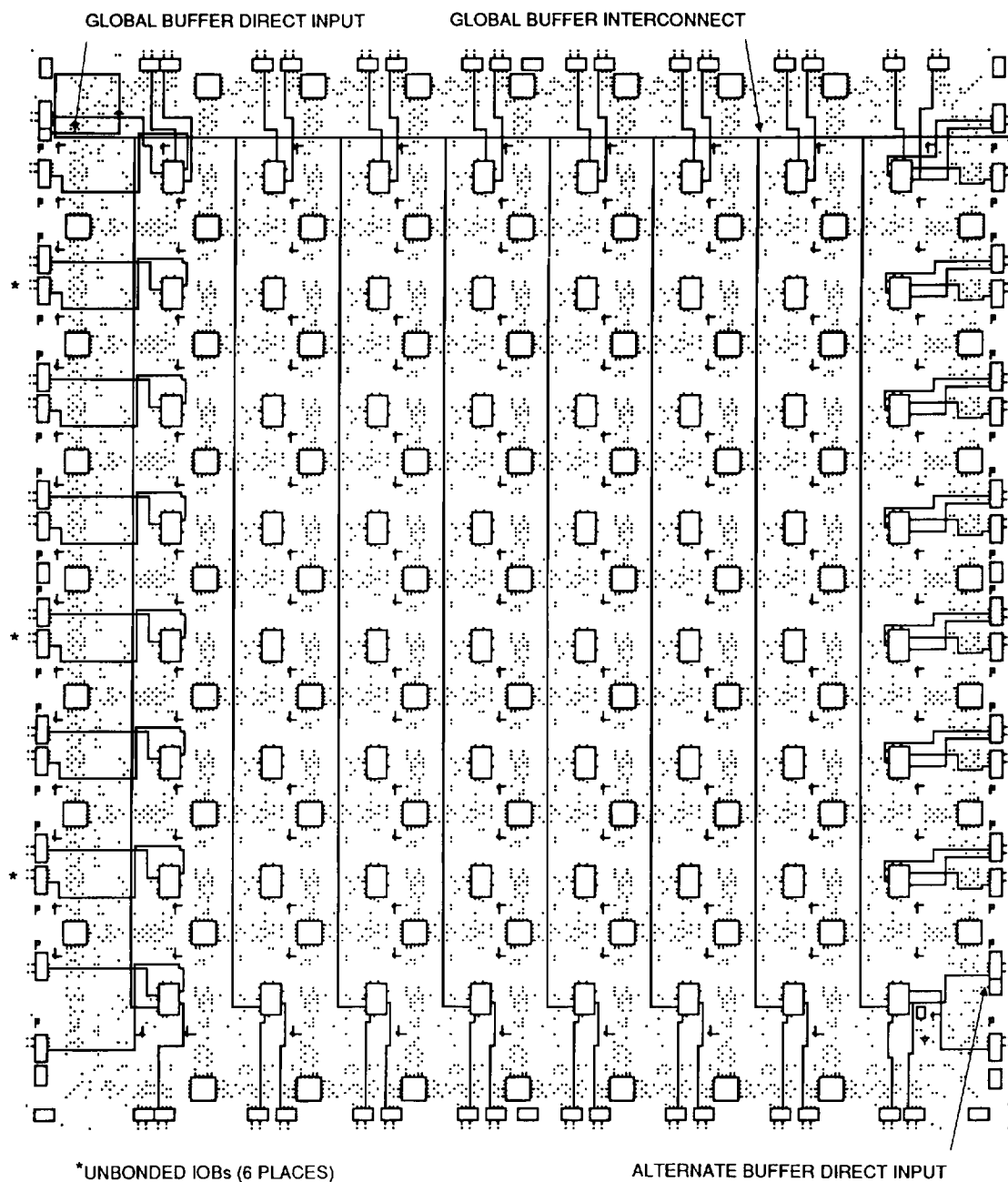


Figure 12. ATT3020 die edge I/O blocks are provided with direct access to adjacent CLBs.

block using the direct interconnect exhibit minimum interconnect propagation and use no general interconnect resources. For each Configurable Logic Block, the .x output may be connected directly to the .b input of the CLB immediately to its right and to the .c input of the CLB to its left. The .y output can use direct interconnect to drive the .d input of the block immediately above and the .a input of the block below. Direct interconnect should be used to maximize the speed of high performance portions of logic. Where logic blocks are adjacent to I/O Blocks, direct connect is provided alternately to the I/O Block inputs [.i] and outputs [.o] on all four edges of the die. The right edge provides additional direct connects from CLB outputs to adjacent IOBs. Direct interconnections of I/O Blocks with CLBs are shown in Figure 12.

Long Lines

The long lines bypass the switch matrices and are intended primarily for signals which must travel a long distance, or must have minimum skew among multiple destinations. Long Lines, shown in Figure 13, run vertically and horizontally the height or width of the interconnect area. Each interconnection column has three vertical long lines, and each interconnection row has two horizontal long lines. An additional two long lines are located adjacent to the outer sets of switching matrices. Two vertical long lines in each column are connectible half-length lines, except on the ATT3020, where only the outer long lines serve that function.

Long lines can be driven by a logic block or I/O block output on a column by column basis. This capability provides a common low skew control or clock line within each column of logic blocks. Interconnections of these long lines are shown in Figure 14. Isolation buffers are provided at each input to a long line and are enabled automatically by the development system when a connection is made.

A buffer in the upper left corner of the FPGA chip drives a global net which is available to all .k inputs of logic blocks. Using the global buffer for a clock signal provides a skew-free, high fan-out, synchronized clock for use at any or all of the I/O and logic blocks. Configuration bits for the .k input to each logic block can select this global line or another routing resource as the clock source for its flip-flops. This net may also be programmed to drive the die edge clock lines for I/O Block use. An enhanced speed, CMOS threshold, direct access to this buffer is available at the second pad from the top of the left die edge.

A buffer in the lower right corner of the array drives a horizontal long line that can drive programmed connections to a vertical long line in each interconnection column. This alternate buffer also has low skew and high fan-out. The network formed by this alternate buffer's long lines can be selected to drive the .k inputs of the logic blocks. CMOS threshold, high speed access to this buffer is available from the third pad from the bottom of the right die edge.

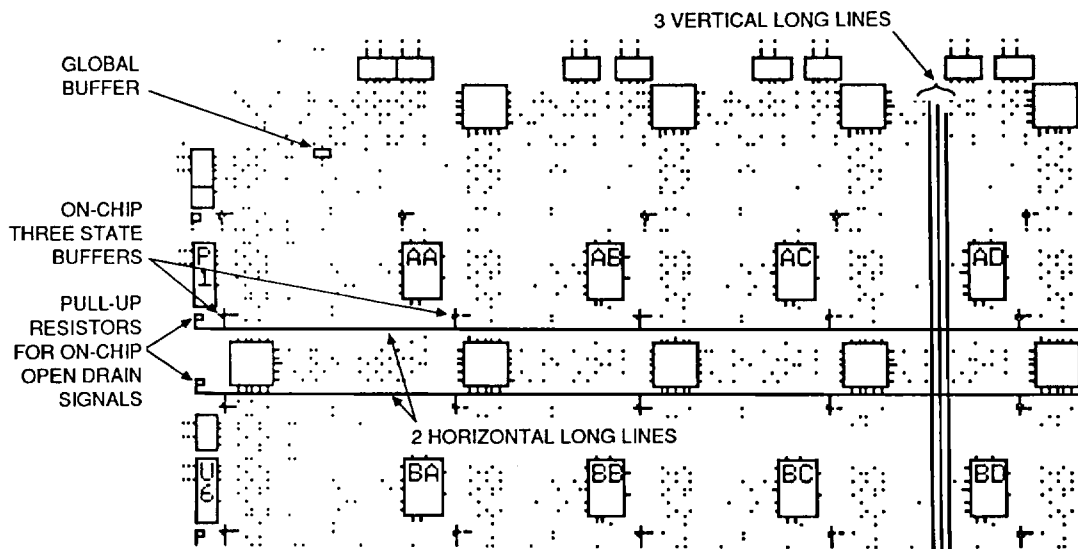


Figure 13. Horizontal and vertical long lines provide high fan-out, low-skew signal distribution in each row and column. The global buffer in the upper left die corner drives a common line throughout the FPGA.

Internal Busses

A pair of three-state buffers is located adjacent to each configurable logic block. These buffers allow logic to drive the horizontal long lines. Logical operation of the three-state buffer controls allows them to implement wide multiplexing functions. Any three-state buffer input can be selected as drive for the horizontal long line bus by applying a low logic level on its three-state control line. See Figure 15a. The user is required to avoid contention which can result from multiple drivers with opposing logic levels. Control of the three-state input by the same signal that drives the buffer input, creates an 'open drain' wired-AND function. A logical HIGH on both buffer inputs creates a high impedance which represents no contention. A logical LOW enables the buffer to drive the long line low. See Figure 15b. Pull-up resistors are available at each end of the long line to provide a HIGH output when all connected buffers are non-conducting. This forms fast, wide gating functions. When data drives the inputs, and separate signals drive the three-state control lines, these buffers form multiplexers (three-state buses). In this case care must be used to prevent contention through multiple active buffers of conflicting levels on a common line. Figure 16 shows three state buffers, long lines and pull-up resistors.

Crystal Oscillator

Figure 16 also shows the location of an internal high speed inverting amplifier which may be used to implement an on-chip crystal oscillator. It is associated with the auxiliary buffer in the lower right corner of the die. When the oscillator is configured by "MAKEBITS" and connected as a signal source, two special user I/O Blocks are also configured to connect the oscillator amplifier with external crystal oscillator components as shown in Figure 17. A divide by two option is available to assure symmetry. The oscillator circuit becomes active before configuration is complete in order to allow the oscillator to stabilize. Actual internal connection is delayed until completion of configuration. In Figure 17 the feedback resistor, R1, between output and input biases the amplifier at threshold. The value should be as large as practical to minimize loading of the crystal. The inversion of the amplifier, together with the R-C networks and an AT cut series resonant crystal, produce the 360 degree phase shift of the Pierce oscillator. A series resistor, R2, may be included to add to the amplifier output impedance when needed for phase shift control, crystal resistance matching, or to limit the amplifier input swing to control clipping at large amplitudes. Excess feedback voltage may be corrected by the ratio of C2/C1. The amplifier

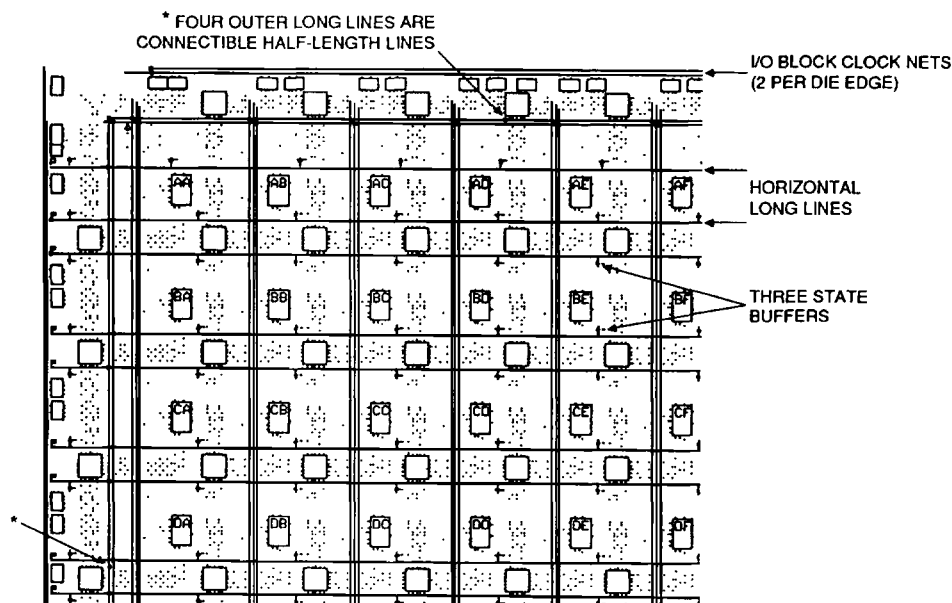
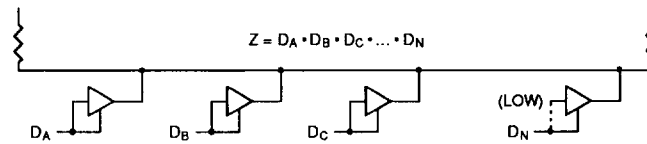
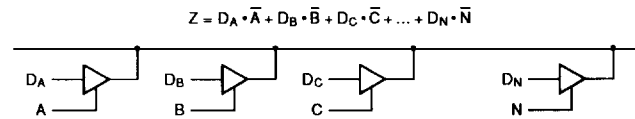
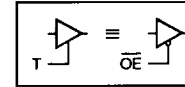


Figure 14. Programmable interconnection of long lines is provided at the edges of the routing area. Three-state buffers allow the use of horizontal long lines to form on-chip wired-AND and multiplexed buses. The left two vertical long lines per column (except ATT3020) and the outer perimeter long lines may be programmed as connectible half-length.



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Figure 15a. Three-state buffers implement a Wired-AND function. When all the buffer three state lines are HIGH, (high impedance), the pull-up resistor(s) provide the HIGH output. The buffer inputs are driven by the control signals or a LOW.



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Figure 15b. Three-state buffers implement a Multiplexer where the selection is accomplished by the buffer three-state signal.

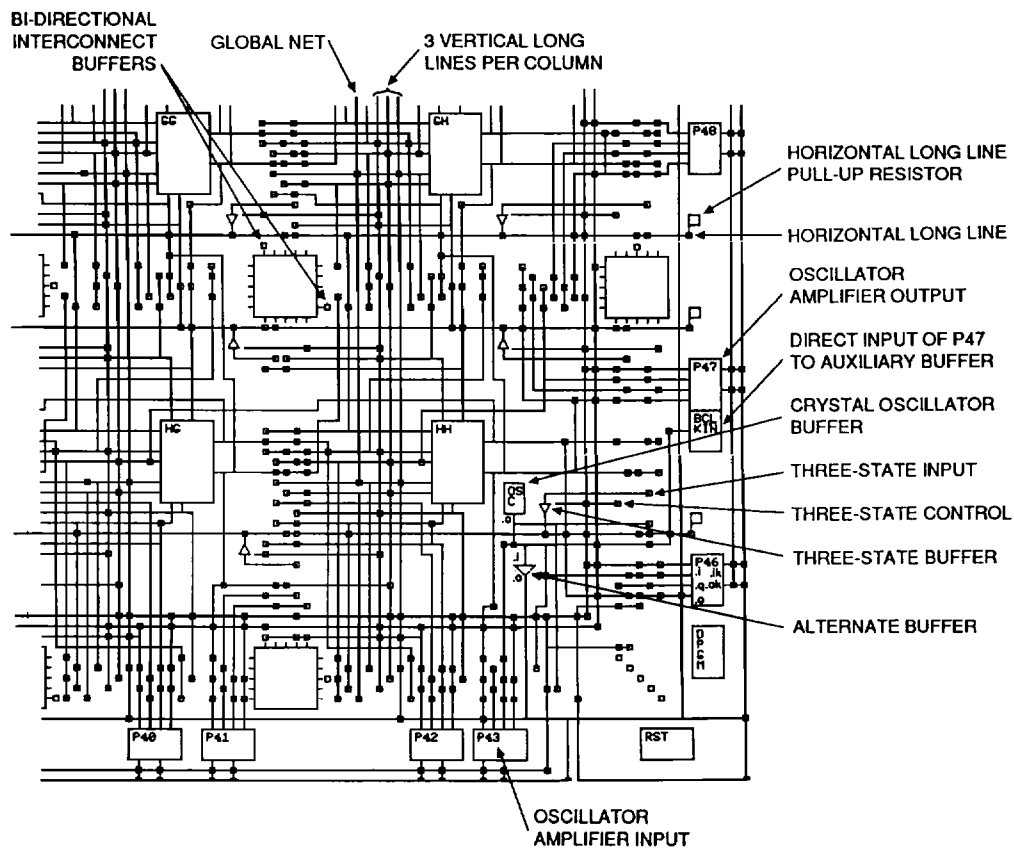


Figure 16. An XACT Development System extra large view of possible interconnections in the lower right corner of the ATT3020.

is designed to be used from 1 MHz to one-half the specified CLB toggle frequency. Use at frequencies below 1 MHz may require individual characterization with respect to a series resistance. Crystal oscillators above 20 MHz generally require a crystal which operates in a third overtone mode, where the fundamental frequency must be suppressed by the R-C networks. When the oscillator inverter is not used, these I/O Blocks and their package pins are available for general user I/O.

PROGRAMMING

Initialization Phase

An internal power-on-reset circuit is triggered when power is applied. When Vcc reaches the voltage at which portions of the FPGA begin to operate (2.5 to 3 Volts), the programmable I/O output buffers are disabled and a high impedance pull-up resistor is provided for the user I/O pins. A time-out delay is initiated to allow the power supply voltage to stabilize. During this time the power-down mode is inhibited. The Initialization state time-out (about 11 to 33 ms) is determined by a 14-bit counter driven by a self-generated,

internal timer. This nominal 1 MHz timer is subject to variations with process, temperature and power supply over the range of 0.5 to 1.5 MHz. As shown in Table 1, five configuration mode choices are available as determined by the input levels of three mode pins; M0, M1 and M2.

In Master configuration modes the FPGA becomes the source of Configuration Clock (CCLK). The beginning of configuration of devices using Peripheral or Slave modes must be delayed long enough for their initialization to be completed. An FPGA with mode lines se-

Table 1

| M0 | M1 | M2 | Clock | Mode | Data |
|----|----|----|---------|------------|-----------------------------|
| 0 | 0 | 0 | active | Master | Bit Serial |
| 0 | 0 | 1 | active | Master | Byte Wide Addr. = 0000 up |
| 0 | 1 | 0 | — | reserved | — |
| 0 | 1 | 1 | active | Master | Byte Wide Addr. = FFFF down |
| 1 | 0 | 0 | — | reserved | — |
| 1 | 0 | 1 | passive | Peripheral | Byte Wide |
| 1 | 1 | 0 | — | reserved | — |
| 1 | 1 | 1 | passive | Slave | Bit Serial |

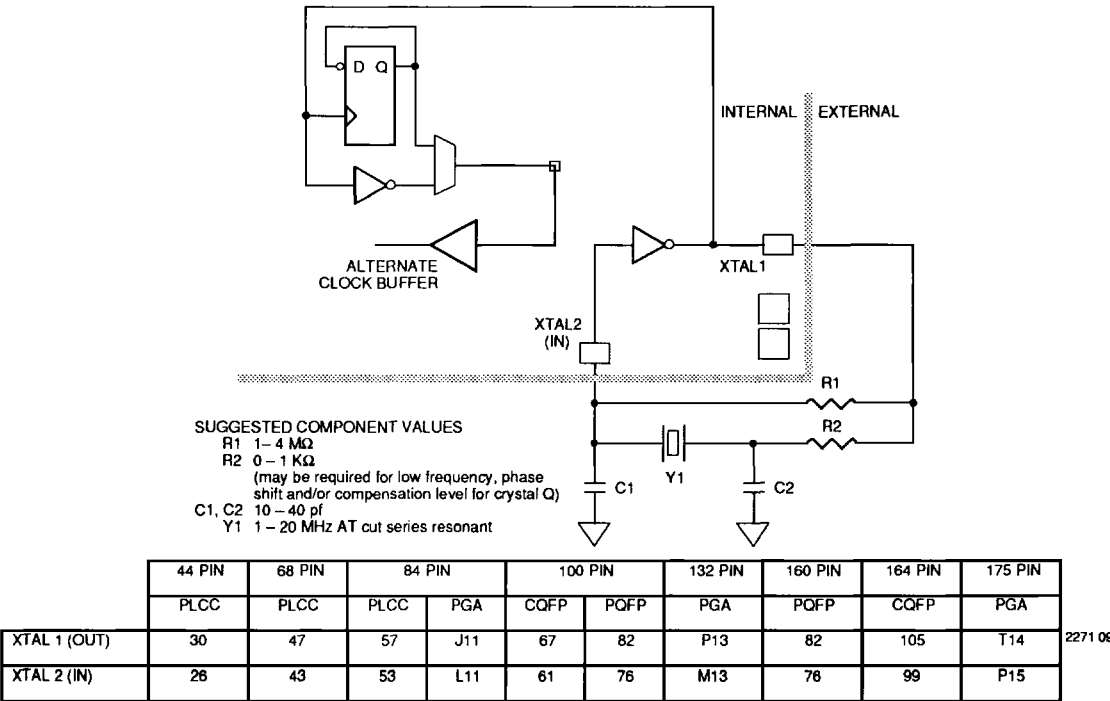


Figure 17. When activated in the "MAKEBITS" program and by selecting an output network for its buffer, the crystal oscillator inverter uses two unconfigured package pins and external components to implement an oscillator. An optional divide-by-two mode is available to assure symmetry.

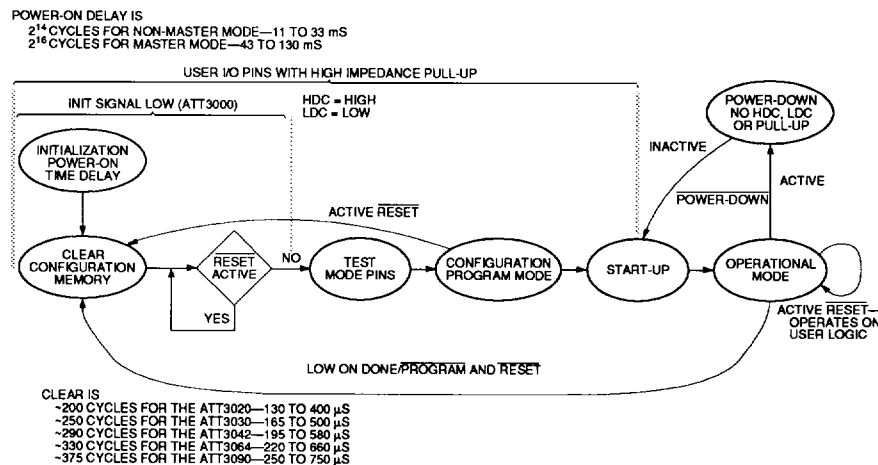
lecting a Master configuration mode extends its initialization state using four times the delay (43 to 130 ms) to assure that all daisy-chained slave devices which it may be driving will be ready even if the master is very fast, and the slave(s) very slow. Figure 18 shows the state sequences. At the end of Initialization the FPGA enters the Clear state where it clears the configuration memory. The active low, open-drain initialization signal $\overline{\text{INIT}}$ indicates when the Initialization and Clear states are complete. The $\overline{\text{FPGA}}$ tests for the absence of an external active low $\overline{\text{RESET}}$ before it makes a final sample of the mode lines and enters the Configuration state. An external wired-AND of one or more $\overline{\text{INIT}}$ pins can be used to control configuration by the assertion of the active low $\overline{\text{RESET}}$ of a master mode device or to signal a processor that the FPGAs are not yet initialized.

If a configuration has begun, a re-assertion of $\overline{\text{RESET}}$ for a minimum of three internal timer cycles will be recognized and the FPGA will initiate an abort, returning to the Clear state to clear the partially loaded configuration memory words. The FPGA will then re-sample $\overline{\text{RESET}}$ and the mode lines before re-entering the Configuration state. A re-program is initiated when a configured FPGA senses a HIGH to LOW transition on the DONE/PROG package pin. The FPGA returns to the Clear state where the configuration memory is cleared and mode lines re-sampled, as for an aborted configuration. The complete configuration program is cleared and loaded during each configuration program cycle.

Length count control allows a system of multiple FPGAs, of assorted sizes, to begin operation in a syn-

chronized fashion. The configuration program generated by the MakePROM program of the XACT development system begins with a preamble of 11111110010 followed by a 24-bit 'length count' representing the total number of configuration clocks needed to complete loading of the configuration program(s). The data framing is shown in Figure 19. All FPGAs connected in series read and shift preamble and length count in on positive and out on negative configuration clock edges. An FPGA which has received the preamble and length count then presents a HIGH Data Out until it has intercepted the appropriate number of data frames. When the configuration program memory of an FPGA is full and the length count does not compare, the FPGA shifts any additional data through, as it did for preamble and length count.

When the FPGA configuration memory is full and the length count compares, the FPGA will execute a synchronous start-up sequence and become operational. See Figure 20. Three CCLK cycles after the completion of loading configuration data the user I/O pins are enabled as configured. As selected in MAKEBITS, the internal user-logic reset is released either one clock cycle before or after the I/O pins become active. A similar timing selection is programmable for the DONE/PROG output signal. DONE/PROG may also be programmed to be an open drain or include a pull-up resistor to accommodate wired ANDing. The High During Configuration (HDC) and Low During Configuration (LDC) are two user I/O pins which are driven active when an FPGA is in its Initialization, Clear or Configure states. They and DONE/PROG provide signals for control of external logic signals such as reset, bus enable or PROM enable during configuration. For



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Figure 18. A state diagram of the configuration process for power-up and reprogram.

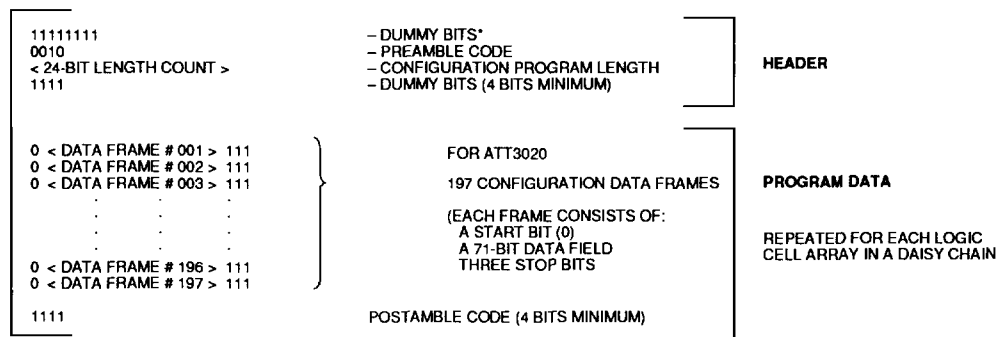
parallel Master configuration modes these signals provide PROM enable control and allow the data pins to be shared with user logic signals.

User I/O inputs can be programmed to be either TTL or CMOS compatible thresholds. At power-up, all inputs have TTL thresholds and can change to CMOS thresholds at the completion of configuration if the user has selected CMOS thresholds. The threshold of PW-RDWN and the direct clock inputs are fixed at a CMOS level.

If the crystal oscillator is used it will begin operation before configuration is complete to allow time for stabilization before it is connected to the internal circuitry.

Configuration Data

Configuration data to define the function and interconnection within a FPGA are loaded from an external storage at power-up and on a re-program signal. Several methods of automatic and controlled loading of the required data are available. Logic levels applied to



*The FPGA Devices Require 4 Dummy Bits Min., XACT3.0 Generates 8 Dummy Bits

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| Device | ATT3020 | ATT3030 | ATT3042 | ATT3064 | ATT3090 |
|--|---------|-----------|-----------|-----------|-----------|
| Gates | 2000 | 3000 | 4200 | 6400 | 9000 |
| CLBs | 64 | 100 | 144 | 224 | 320 |
| Row X Col | (8 X 8) | (10 X 10) | (12 X 12) | (16 X 14) | (20 X 16) |
| IOBs | 64 | 80 | 96 | 120 | 144 |
| Flip-flops | 256 | 360 | 480 | 688 | 928 |
| Bits per frame (w/ 1 start 3 stop) | 75 | 92 | 108 | 140 | 172 |
| Frames | 197 | 241 | 285 | 329 | 373 |
| Program Data = Bits * Frames + 4 (excludes header) | 14779 | 22176 | 30784 | 46064 | 64160 |
| PROM size (bits) = Program Data + 40 bit Headers | 14819 | 22216 | 30824 | 46104 | 64200 |

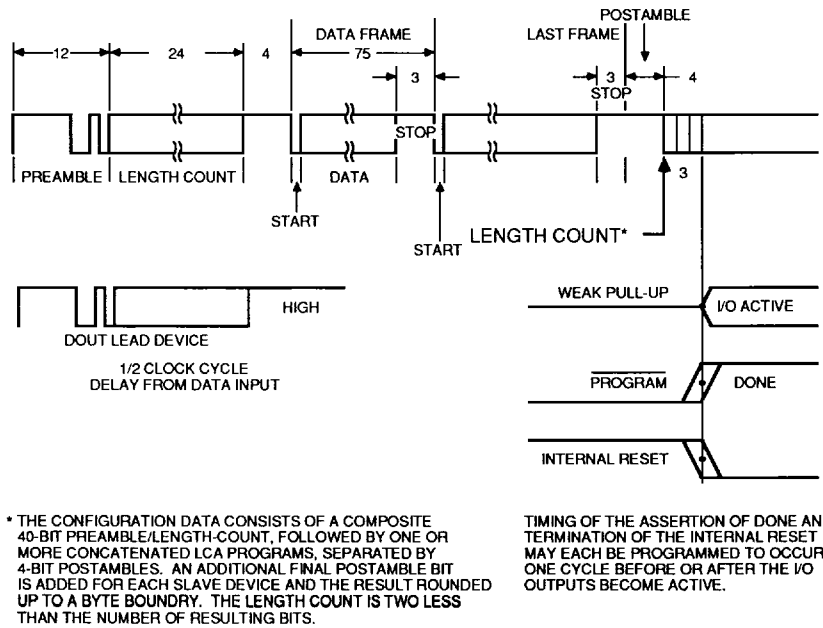
Figure 19. The internal Configuration Data Structure for an FPGA shows the preamble, length count and data frames which are generated by the XACT Development System.

The Length Count produced by the "MAKEBIT" program = [(40-bit preamble + sum of program data + 1 per daisy chain device) rounded up to multiple of 8] - (2 ≤ K ≤ 4) where K is a function of DONE and RESET timing selected. An additional 8 is added if roundup increment is less than K. K additional clocks are needed to complete start-up after length count is reached.

mode selection pins at the start of configuration time determine the method to be used. See Table 1. The data may be either bit-serial or byte-parallel, depending on the configuration mode. Various AT&T Programmable Gate Arrays have different sizes and numbers of data frames. For the ATT3020, configuration requires 14779 bits for each device, arranged in 197 data frames. An additional 40 bits are used in the header. See Figure 20. The specific data format for each device is produced by the MAKEBITS command of the development system and one or more of these files can then be combined and appended to a length count preamble and be transformed into a PROM format file by the 'MAKE PROM' command of the XACT development system. The "tie" option of the MAKEBITS program defines output levels of unused blocks of a design and connects these to unused routing resources. This prevents indeterminant levels which might produce parasitic supply currents. If unused blocks are not sufficient to complete the 'tie,' the FLAGNET command of EDITFPGA can be used to indicate nets which must not be used to drive the remaining unused routing, as that might affect timing of user nets. NORESTORE will retain the results of TIE for timing analysis with QUERYNET before RESTORE returns the design to the untied condition. TIE can be omitted for quick breadboard iterations where a few additional mA of I_{CC} are acceptable.

The configuration bit-stream begins with HIGH preamble bits, a four-bit preamble code and a 24-bit length count. When configuration is initiated, a counter in the FPGA is set to 0 and begins to count the total number of configuration clock cycles applied to the device. As each configuration data frame is supplied to the FPGA, it is internally assembled into a data word. As each data word is completely assembled, it is loaded in parallel into one word of the internal configuration memory array. The configuration loading process is complete when the current length count equals the loaded length count and the required configuration program data frames have been written. Internal user flip-flops are held reset during configuration.

Two user programmable pins are defined in the unconfigured FPGA. High During Configuration (HDC) and Low During Configuration (LDC) as well as DONE/PROG may be used as external control signals during configuration. In Master mode configurations it is convenient to use LDC as an active-low EPROM Chip Enable. After the last configuration data-bit is loaded and the length count compares, the user I/O pins become active. Options in the MAKEBITS program allow timing choices of one clock earlier or later for the timing of the end of the internal logic reset and the assertion of the DONE signal. The open-drain DONE/PROG out-



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Figure 20. Configuration and start-up of one or more FPGAs.

put can be AND-tied with multiple FPGAs and used as an active high READY, an active low PROM enable or a RESET to other portions of the system. The state diagram of Figure 18 illustrates the configuration process.

Master Mode

In Master mode, the FPGA automatically loads configuration data from an external memory device. There are three Master modes which use the internal timing source to supply the configuration clock (CCLK) to time the incoming data. Serial Master mode uses

serial configuration data supplied to data-in (DIN) from a synchronous serial source such as the serial configuration PROM shown in Figure 21. Parallel Master Low and Master High modes automatically use parallel data supplied to the D0–D7 pins in response to the 16-bit address generated by the FPGA. Figure 22 shows an example of the parallel Master mode connections required. The FPGA HEX starting address is 0000 and increments for Master Low mode and it is FFFF and decrements for Master High mode. These two modes provide address compatibility with microprocessors which begin execution from opposite ends of memory. For Master high or low, data bytes are

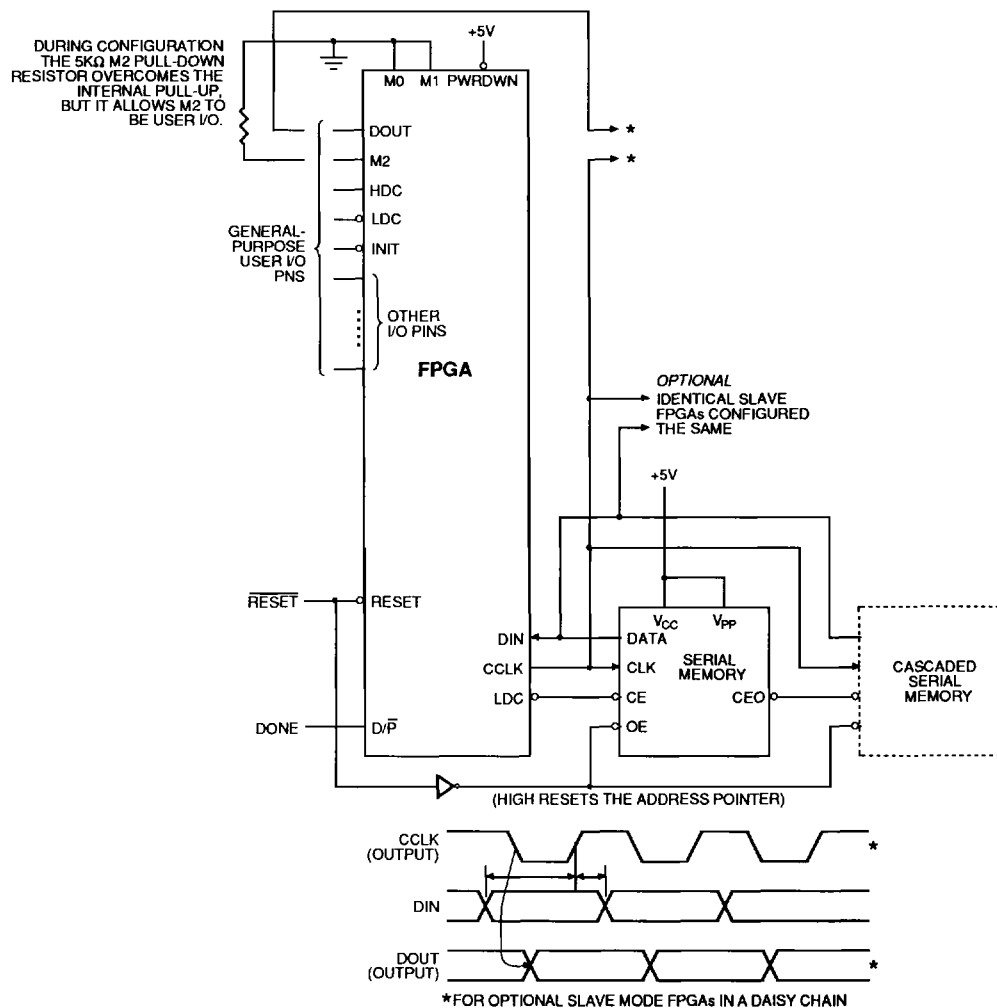


Figure 21. Master Serial Mode. The serial configuration PROM supports automatic loading of configuration programs up to 36K/64K bits. Multiple devices can be cascaded to support additional FPGAs. An early DONE inhibits the data output a CCLK cycle before the FPGA I/O become active.

read in parallel by each read clock (RCLK) and internally serialized by the configuration clock. As each data byte is read, the least significant bit of the next byte, D0, becomes the next bit in the internal serial configuration word. One Master mode FPGA can be

used to interface the configuration program-store and pass additional concatenated configuration data to additional FPGAs in a serial daisy-chain fashion. CCLK is provided for the slaved devices and their serialized data is supplied from DOUT to DIN - DOUT to DIN etc.

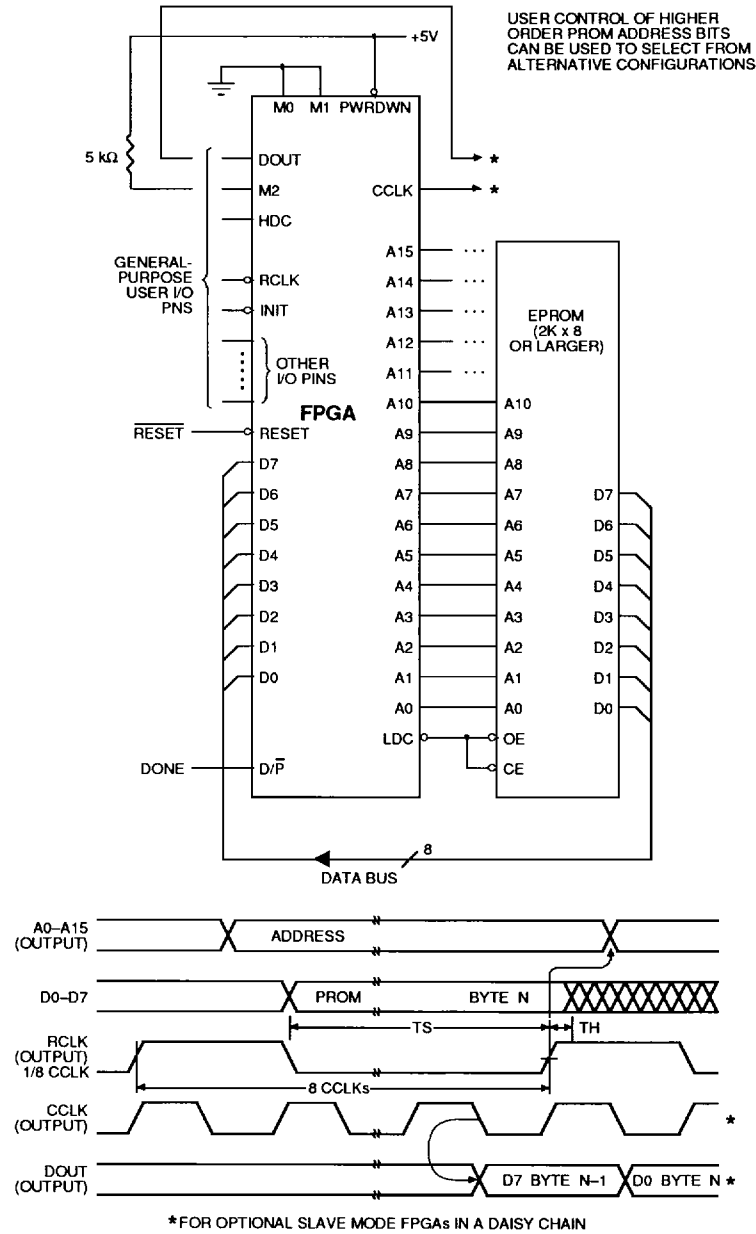


Figure 22. Master Parallel Mode. Configuration data are loaded automatically from an external byte wide PROM. An early DONE inhibits the PROM outputs a CCLK before the FPGA I/O become active.

Peripheral Mode

Peripheral mode provides a simplified interface through which the device may be loaded byte-wide, as a processor peripheral. Figure 23 shows the peripheral mode connections. Processor write cycles are decoded from the common assertion of the active low Write Strobe (\overline{WS}), and two active low and one active high Chip Selects ($\overline{CS0}$, $\overline{CS1}$, $CS2$). If all these signals are not available, the unused inputs should be driven to their respective active levels. The FPGA will accept one byte of configuration data on the D0–D7 inputs for each selected processor Write cycle. Each byte of data is loaded into a buffer register. The FPGA generates a configuration clock from the internal timing generator and serializes the parallel input data for internal framing or for succeeding slaves on Data Out

(DOUT). A output HIGH on $\overline{RDY}/\overline{BUSY}$ pin indicates the completion of loading for each byte when the input register is ready for a new byte. As with Master modes, Peripheral mode may also be used as a lead device for a daisy-chain of slave devices.

Slave Mode

Slave mode provides a simple interface for loading the FPGA configuration as shown in Figure 24. Serial data are supplied in conjunction with a synchronizing input clock. Most Slave mode applications are in daisy-chain configurations in which the data input are supplied by the previous FPGA's data out, while the clock is supplied by a lead device in Master or Peripheral mode. Data may also be supplied by a processor or other special circuits.

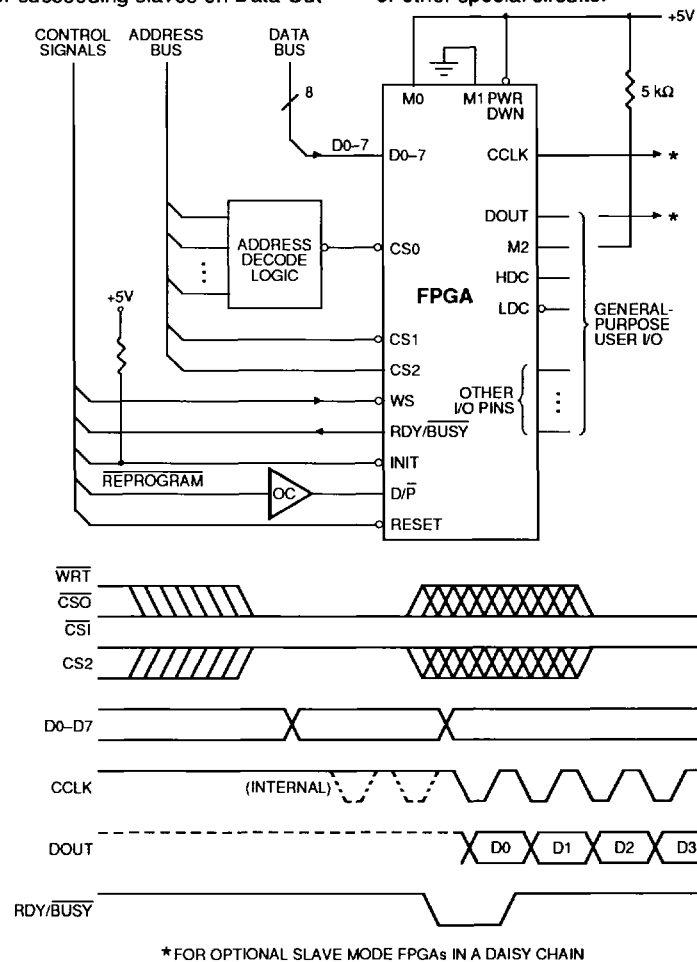


Figure 23. Peripheral Mode. Configuration data are loaded using a byte-wide data bus from a microprocessor.

Special Configuration Functions

The configuration data include control over several special functions in addition to the normal user logic functions and interconnect:

- Input thresholds
- Readback enable
- DONE pull-up resistor
- DONE timing
- RESET timing
- Oscillator frequency divided by two

Each of these functions is controlled by configuration data bits which are selected as part of the normal XACT development system bit-stream generation process.

Input Thresholds

Prior to the completion of configuration all FPGA input thresholds are TTL compatible. Upon completion of configuration the input thresholds become either TTL or CMOS compatible as programmed. The use of the TTL threshold option requires some additional supply current for threshold shifting. The exception is the threshold of the **PWRDWN** input and direct clocks which always have a CMOS input. Prior to the completion of configuration the user I/O pins each have a high impedance pull-up. The configuration program can be used to enable the I/O Block pull-up resistors in the Operational mode to act either as an input load or to avoid a floating input on an otherwise unused pin.

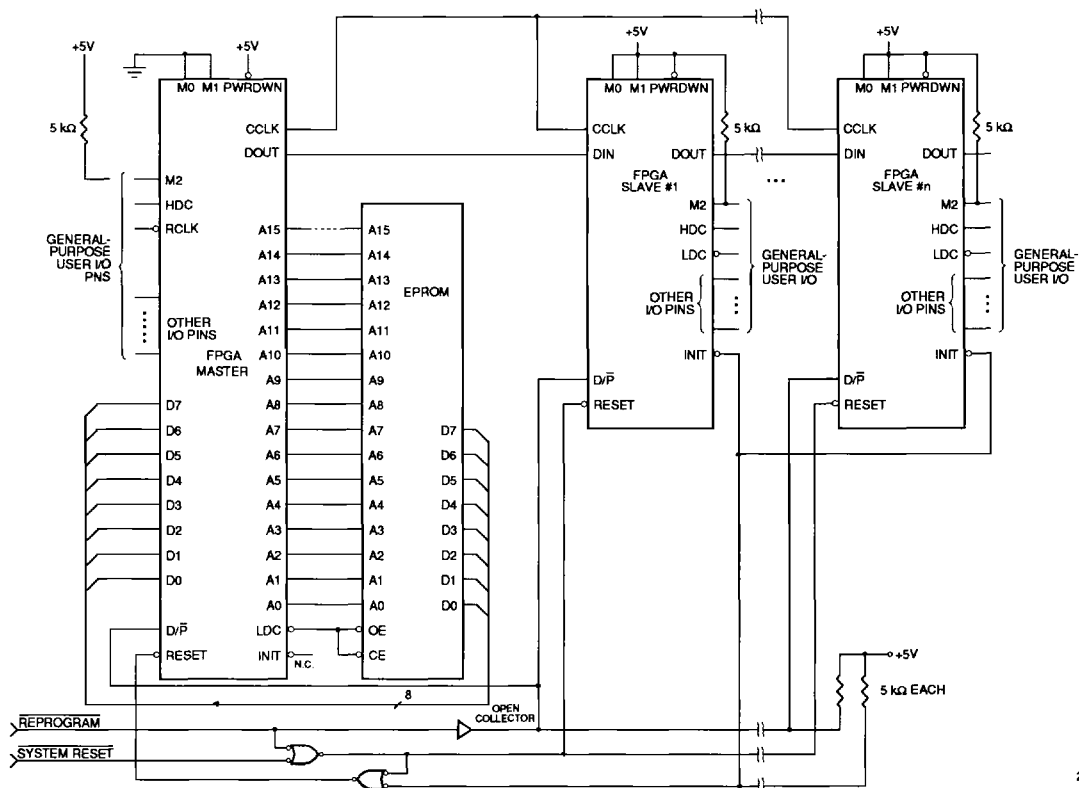


Figure 25. Master Mode configuration with daisy chained slave mode devices. All are configured from the common EPROM source. The Slave mode device **INIT** signals delay the Master device configuration until they are initialized. A well defined termination of SYSTEM RESET is needed when controlling multiple FPGAs.

Readback

The contents of a FPGA may be read back if it has been programmed with a bit-stream in which the Readback option has been enabled. Readback may be used for verification of configuration and as a method of determining the state of internal logic nodes during debugging with the Data I/O Mesa-I In-Circuit Verifier. There are three options in generating the configuration bit-stream:

- "Never" will inhibit the Readback capability.
- "One-time," will inhibit Readback after one Readback has been executed to verify the configuration.
- "On-command" will allow unrestricted use of Readback.

Readback is accomplished without the use of any of the user I/O pins; only M0, M1 and CCLK are used. The initiation of readback is produced by a LOW to HIGH transition of the M0/RTRIG (Read Trigger) pin. Once the readback command has been given, the input CCLK is driven by external logic to read back each data bit in a format similar to loading. After two dummy bits, the first data frame is shifted out, in inverted sense, on the M1/RDATA (Read Data) pin. All data frames must be read back to complete the process and return the mode select and CCLK pins to their normal functions.

The readback data includes the current state of each internal logic block storage element, and the state of the *[.i* and *.r]* connection pins on each I/O Block. These data are imbedded into unused configuration bit positions during readback. This state information is used by the FPGA development system In-Circuit Verifier to provide visibility into the internal operation of the logic while the system is operating. To readback a uniform time-sample of all storage elements it may be necessary to inhibit the system clock.

Re-program

The FPGA configuration memory can re-written while the device is operating in the user's system. To initiate a re-programming cycle, the dual function package pin DONE/PROG must be given a HIGH to LOW transition. To reduce sensitivity to noise, the input signal is filtered for 2 cycles of the FPGA's internal timing generator. When re-program begins, the user programmable I/O output buffers are disabled and high impedance pull-ups are provided for the package pins. The

device returns to the Clear state and clears the configuration memory before it indicates 'initialized'. Since this clear operation uses chip-individual internal timing, the master might complete the clear operation and then start configuration before the slave has completed the clear operation. To avoid this problem, wire-AND the slave INIT pins and use them to force a RESET on the master (see Figure 25). Reprogram control is often implemented using an external open collector driver which pulls DONE/PROG LOW. Once it recognizes a stable request, the FPGA will hold a LOW until the new configuration has been completed. Even if the re-program request is externally held LOW beyond the configuration period, the FPGA will begin operation upon completion of configuration.

DONE Pull-up

DONE/PROG is an open drain I/O pin that indicates the FPGA is in the operational state. An optional internal pull-up resistor can be enabled by the user of the XACT development system when 'Make Bits' is executed. The DONE/PROG pins of multiple FPGAs in a daisy-chain may be connected together to indicate all are DONE or to direct them all to re-program.

DONE Timing

The timing of the DONE status signal can be controlled by a selection in the MAKEBITS program to occur a CCLK cycle before, or after, the timing of outputs being activated. See Figure 20. This facilitates control of external functions such as a PROM enable or holding a system in a wait state.

RESET Timing

As with DONE timing, the timing of the release of the internal RESET can be controlled by a selection in the MAKEBITS program to occur a CCLK cycle before, or after, the timing of outputs being enabled. See Figure 20. This reset maintains all user programmable flip-flops and latches in a 'zero' state during configuration.

Crystal Oscillator Division

A selection in the MAKEBITS program allows the user to incorporate a dedicated divide-by-two flip-flop in the crystal oscillator function. This provides higher assurance of a symmetrical timing signal. Although the frequency stability of crystal oscillators is high, the symmetry of the waveform can be affected by bias or feedback drive.

PERFORMANCE

Device Performance

The high performance of the FPGA is due in part to the manufacturing process, which is similar to that used for high speed CMOS static memories. Performance can be measured in terms of minimum propagation times for logic elements. The parameter which traditionally describes the overall performance of a gate array is the toggle frequency of a flip-flop. The configuration for determining the toggle performance of the FPGA is shown in Figure 26. The flip-flop output Q is fed back through the combinatorial logic as Q to form the toggle flip-flop.

Actual FPGA performance is determined by the timing of critical paths, including both the fixed timing for the logic and storage elements in that path, and the timing associated with the routing of the network. Examples of internal worst case timing are included in the performance data to allow the user to make the best use of the capabilities of the device. The *XACT* development system timing calculator or *XACT* generated simulation models should be used to calculate worst case paths by using actual impedance and loading information. Figure 27 shows a variety of elements which are involved in determining system performance. Actual measurement of internal timing is not practical and often only the sum of component timing is relevant as in the case of input to output. The relationship between input and output timing is arbitrary and only the total determines performance. Timing components of internal functions may be determined by measurement of differences at the pins of the package. A synchronous logic function which involves a clock to block-output, and a block-input to clock set-up is capable of higher speed operation than a logic configuration of two synchronous blocks with an extra combinatorial block level between them. System clock rates to 60% of the toggle frequency are practical for logic in which an extra combinatorial level is located between synchronized blocks. This allows implementation of functions of up to 25 variables. The use of the wired-AND is also available for wide, high speed functions.

Logic Block Performance

Logic block performance is expressed as the propagation time from the interconnect point at the input of the combinatorial logic to the output of the block in the interconnect area. Combinatorial performance is independent of the specific logic function because of the table look-up based implementation. Timing is different when the combinatorial logic is used in conjunction

with the storage element. For the combinatorial logic function driving the data input of the storage element, the critical timing is data set-up relative to the clock edge provided to the flip-flop element. The delay from the clock source to the output of the logic block is critical in the timing of signals produced by storage elements. Loading of a Logic Block output is limited only by the resulting propagation delay of the larger interconnect network. Speed performance of the logic block is a function of supply voltage and temperature. See Figures 28 and 29.

Interconnect Performance

Interconnect performance depends on the routing resource used to implement the signal path. As discussed earlier, direct interconnect from block to block provides a fast path for a signal. The single metal segment used for Long lines exhibits low resistance from end to end, but relatively high capacitance. Signals driven through a programmable switch will have the additional impedance of the switch added to their normal drive impedance.

General purpose interconnect performance depends on the number of switches and segments used, the presence of the bi-directional re-powering buffers and the overall loading on the signal path at all points along the path. In calculating the worst case timing for a general interconnect path the timing calculator portion of the *XACT* development system accounts for all of these elements. As an approximation, interconnect timing is proportional to the summation of totals of local metal segments beyond each programmable switch. In effect, the time is a sum of R-C time each approximated by an R times the total C it drives. The R of the switch and the C of the interconnect are functions of the particular device performance grade. For a string of three local interconnects, the approximate time at the first segment, after the first switch resistance would be three units; an additional two units after the next switch plus an additional unit after the last switch in the chain. The interconnect R-C chain terminates at each re-powering buffer. The capacitance of

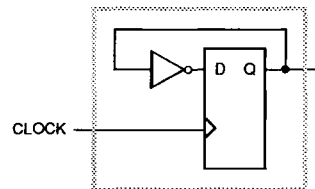
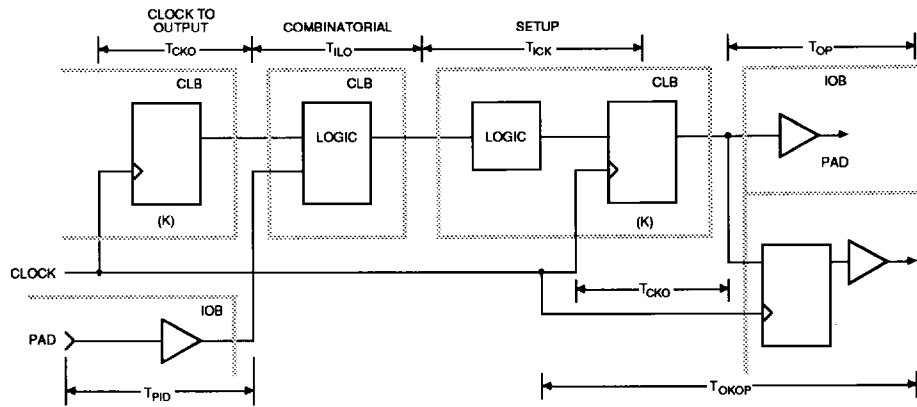


Figure 26. "Toggle" Flip-Flop used to characterize device performance.

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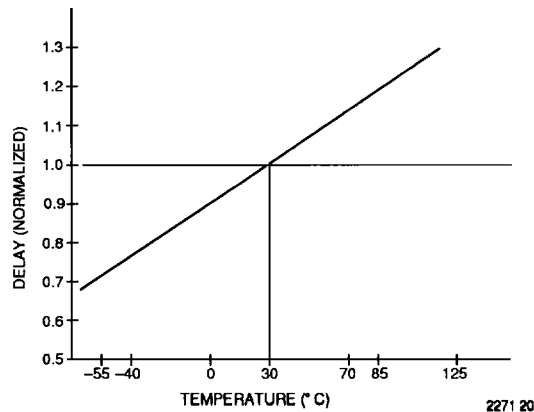


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| Signal | Description | Speed (4) | -70 | | -100 | | -125 | | 150 | | Unit |
|-----------------------|-------------------------|-----------|-----|-----|------|-----|------|-----|-----|-----|------|
| | | | Min | Max | Min | Max | Min | Max | Min | Max | |
| Logic input to Output | Combinatorial | TILO | | 9 | | 7 | | 5.5 | | 4.6 | ns |
| K Clock | To output | TCKO | | 6 | | 5 | | 4.5 | | 4 | ns |
| | Logic-input setup | TICK | 8 | | 7 | | 5.5 | | 4.6 | | ns |
| | Logic-input hold | TCKI | 0 | | 0 | | 0 | | 0 | | ns |
| Input/Output | Pad to input (direct) | TPID | | 6 | | 4 | | 3 | | 2.8 | ns |
| | Output to pad (fast) | TOP | | 9 | | 6 | | 5 | | 4.5 | ns |
| | I/O clock to pad (fast) | TOKPO | | 13 | | 10 | | 9 | | 7 | ns |
| FF toggle frequency | | FCLK | | 70 | | 100 | | 125 | | 150 | MHz |

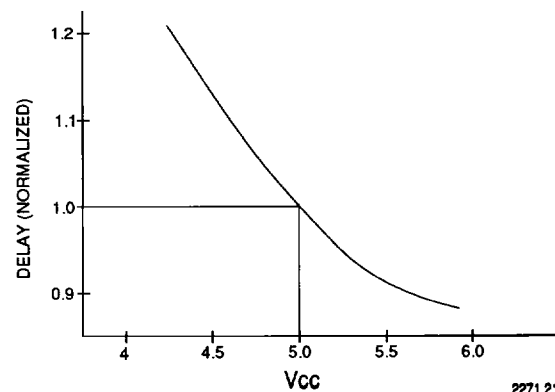
■ = Preliminary.

Figure 27. Examples of Primary Block Speed Factors. Actual timing is a function of various block factors combined with routing factors. Overall performance can be evaluated with the XACT timing calculator or by an optional simulation.



2271 20

Figure 28. Change in speed performance as a function of temperature, normalized for 30°C.



2271 21

Figure 29. The speed performance of a CMOS device increases with Vcc within the operating range.

the actual block inputs is not significant; the capacitance is in the interconnect metal and switches. Figure 30 illustrates this.

POWER

Power Distribution

Power for the FPGA is distributed through a grid to achieve high noise immunity and isolation between logic and I/O. Inside the FPGA, a dedicated Vcc and ground ring surrounding the logic array provides power to the I/O drivers. See Figure 31. An independent matrix of Vcc and ground lines supplies the interior logic of the device. This power distribution grid provides a stable supply and ground for all internal logic, providing the external package power pins are all connected and appropriately decoupled. Typically a 0.1 μ F capacitor connected near the Vcc and ground pins of the package will provide adequate decoupling.

Output buffers capable of driving the specified 4 mA loads under worst-case conditions. Noise can be reduced by minimizing external load capacitance and reducing simultaneous output transitions in the same direction. It may also be beneficial to locate heavily loaded output buffers near the ground pads. The I/O Block output buffers have a slew limited mode which

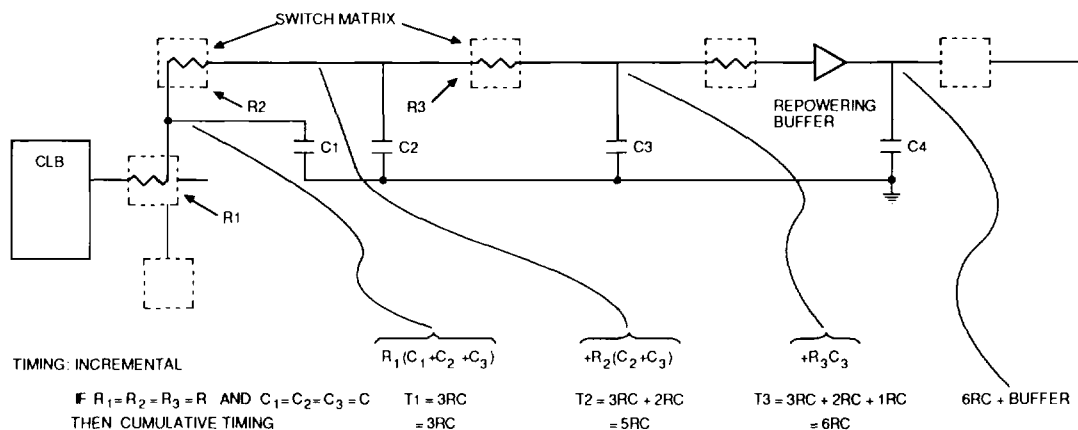
should be used where output rise and fall times are not speed critical.

Slew-limited outputs maintain their DC drive capability, but generate less external reflections and internal noise. More than 32 fast outputs should not be switching in the same direction exactly simultaneously. A few ns of deliberate skew can alleviate this problem of "ground-bounce".

Power Dissipation

The FPGA exhibits the low power consumption characteristic of CMOS ICs. For any design the user can use Figure 32 to calculate the total power requirement based on the sum of the capacitive and DC loads both external and internal. The configuration option of TTL chip input threshold requires power for the threshold reference. The power required by the static memory cells which hold the configuration data is very low and may be maintained in a power-down mode.

Typically most of power dissipation is produced by external capacitive loads on the output buffers. This load and frequency dependent power is 25 μ W/pF/MHz per output. Another component of I/O power is the DC loading on each output pin by devices driven by the FPGA.



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Figure 30. Interconnection timing example. Use of the XACT timing calculator or XACT-generated simulation model provide actual worstcase performance information.

Internal power dissipation is a function of the number and size of the nodes, and the frequency at which they change. In an FPGA the fraction of nodes changing on a given clock is typically low (10–20%). For example, in a large binary counter, the average clock cycle produces changes equal to one CLB output at the clock frequency. Typical global clock buffer power is between 1.7 mW/MHz for the ATT3020 and 3.6 mW/MHz for the ATT3090. The internal capacitive load is more a function of interconnect than fan-out. With a “typical” load of three general interconnect segments, each Configurable Logic Block output requires about 0.4 mW per MHz of its output frequency.

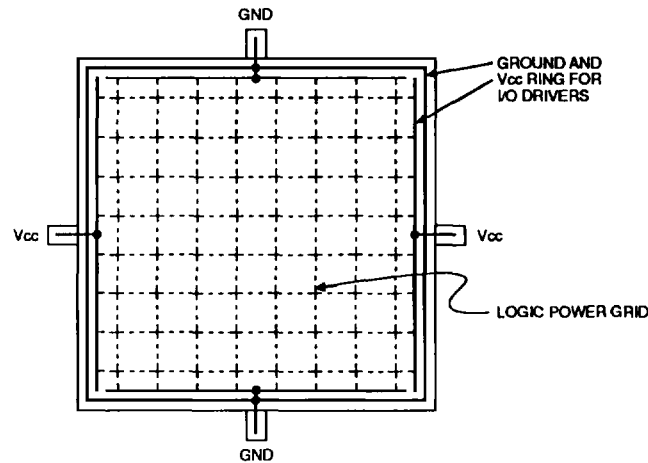
$$\text{Total Power} = V_{cc} \cdot I_{cco} + \text{external (DC + capacitive)} + \text{internal (CLB + IOB + Long Line + pull-up)}$$

Because the control storage of the FPGA is CMOS static memory, its cells require a very low standby current for data retention. In some systems, this low data retention current characteristic can be used as a method of preserving configurations in the event of a primary power loss. The FPGA has built in power-down logic which, when activated, will disable normal operation of the device and retain only the configuration data. All internal operation is suspended and output buffers are placed in their high impedance state

with no pull-ups. Power-down data retention is possible with a simple battery-backup circuit because the power requirement is extremely low. For retention at 2.4 volts the required current is typically on the order of 50 nanoamps.

To force the FPGA into the Power-Down state, the user must pull the PWRDWN pin low and continue to supply a retention voltage to the V_{cc} pins of the package. When normal power is restored, V_{cc} is elevated to its normal operating voltage and PWRDWN is returned to a HIGH. The FPGA resumes operation with the same internal sequence that occurs at the conclusion of configuration. Internal I/O and logic block storage elements will be reset, the outputs will become enabled and the DONE/PROG pin will be released. No configuration programming is involved.

When the power supply is removed from a CMOS device it is possible to supply some power from an input signal. The conventional electro-static input protection is implemented with diodes to the supply and ground. A positive voltage applied to an input (or output) will cause the positive protection diode to conduct and drive the power pin. This condition can produce invalid power conditions and should be avoided. A large series resistor might be used to limit the current or a bi-polar buffer may be used to isolate the input signal.



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Figure 31. FPGA Power Distribution.

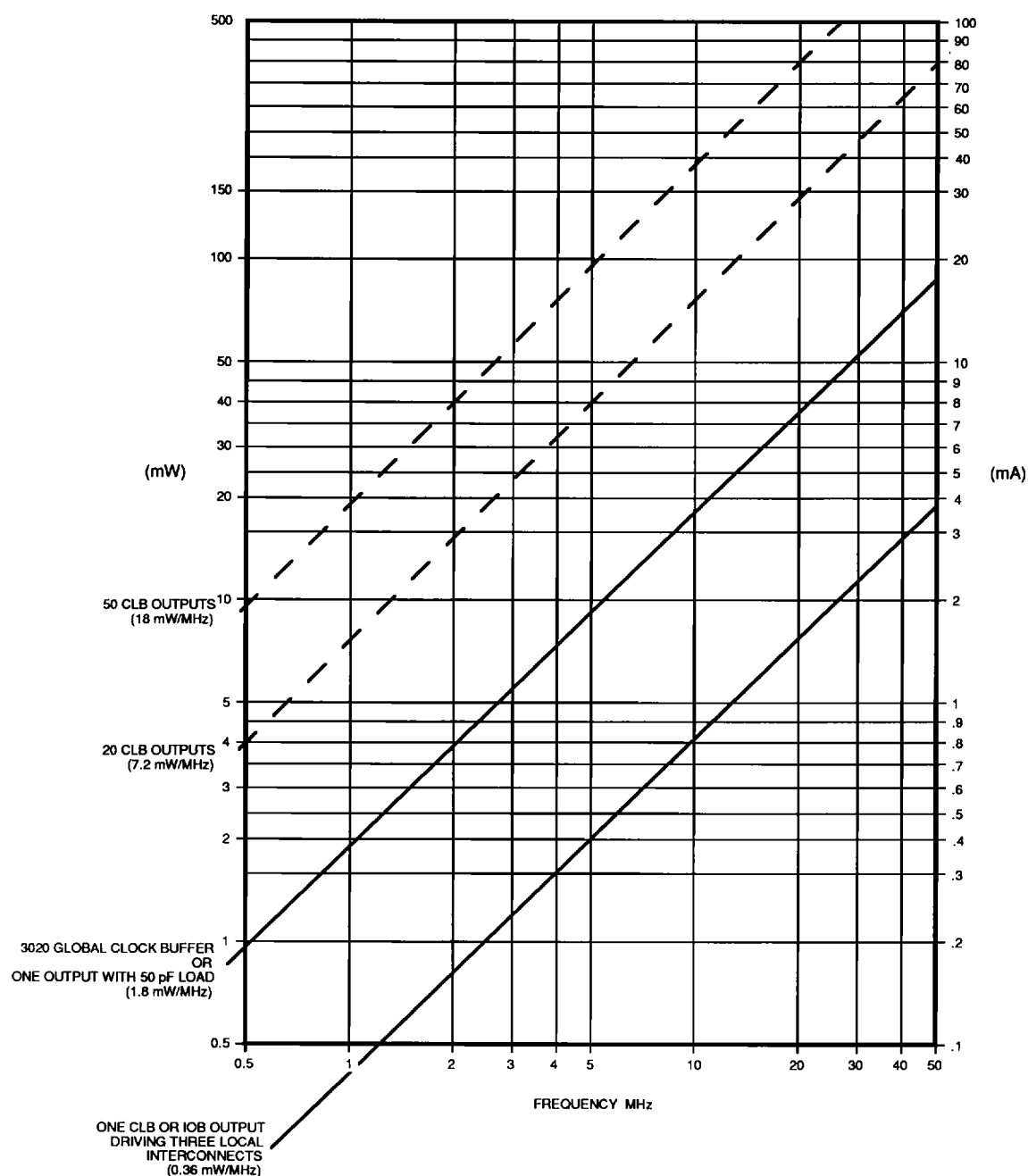


Figure 32. FPGA Power Consumption by Element. Total chip power is the sum of $V_{CC} \cdot I_{CC0}$ plus effective internal and external values of frequency dependent capacitive charging currents and duty factor dependent resistive loads.

PIN DESCRIPTIONS**1. Permanently Dedicated Pins.****Vcc**

Two to eight (depending on package type) connections to the nominal +5 V supply voltage. All must be connected.

GND

Two to eight (depending on package type) connections to ground. All must be connected.

PWRDWN

A LOW on this CMOS compatible input stops all internal activity to minimize Vcc power, and puts all output buffers in a high impedance state, but configuration is retained. When the PWRDWN pin returns HIGH, the device returns to operation with the same sequence of buffer enable and DONE/PROGRAM as at the completion of configuration. All internal storage elements are reset. If not used, PWRDWN must be tied to Vcc.

RESET

This is an active low input which has three functions.

Prior to the start of configuration, a LOW input will delay the start of the configuration process. An internal circuit senses the application of power and begins a minimal time-out cycle. When the time-out and RESET are complete, the levels of the "M" lines are sampled and configuration begins.

If RESET is asserted during a configuration, the FPGA is re-initialized and will restart the configuration at the termination of RESET.

If RESET is asserted after configuration is complete it will provide an asynchronous reset of all IOB and CLB storage elements of the FPGA.

CCLK

During configuration, Configuration Clock is an output of an FPGA in Master mode or Peripheral mode. FPGAs in Slave mode use it as a clock input. During a Readback operation it is a clock input for the configuration data being shifted out.

DONE

The DONE output is configurable as open drain with or without an internal pull-up resistor. At the completion of configuration, the circuitry of the FPGA becomes active in a synchronous order, and DONE may be programmed to occur one cycle before or after that.

PROG

Once configuration is done, a HIGH to LOW transition of this pin will cause an initialization of the FPGA and start a reconfiguration.

M0

As Mode 0, this input and M1, M2 are sampled before the start of configuration to establish the configuration mode to be used.

RTRIG

As a Read Trigger, a LOW-to-HIGH input transition, after configuration is complete, will initiate a Readback of configuration and storage element data by CCLK. This operation may be limited to a single request, or be inhibited altogether, by selecting the appropriate readback option when generating the bit stream.

M1

As Mode 1, this input and M0, M2 are sampled before the start of configuration to establish the configuration mode to be used. If Readback is to be used, a 5 KΩ resistor should be used to define mode level inputs.

RDATA

As an active low Read Data, after configuration is complete, this pin is the output of the readback data.

2. User I/O Pins that can have special functions.**M2**

As Mode 2 this input has a passive pullup during configuration. Together with M0 and M1 it is sampled before the start of configuration to establish the configuration mode to be used. After configuration this pin becomes a user programmable I/O pin.

HDC

High During Configuration is held at a HIGH level by the FPGA until after configuration. It is available as a control output indicating that configuration is not yet completed. After configuration this pin is a user I/O pin.

LDC

Low During Configuration is held at a LOW level by the FPGA until after configuration. It is available as a control output indicating that configuration is not yet completed. It is particularly useful in Master mode as a LOW enable for an EPROM. After configuration this pin is a user I/O pin. If used as a LOW EPROM enable, it must be programmed as a HIGH after configuration.

INIT

This is an active low open drain output which is held LOW during the power stabilization and internal clearing of the configuration memory. It can be used to indicate status to a configuring microprocessor or, as a wired AND of several slave mode devices, a hold-off signal for a master mode device. After configuration this pin becomes a user programmable I/O pin.

BCLKIN

This is a direct CMOS level input to the alternate clock buffer (Auxiliary Buffer) in the lower right corner.

XTL1

This user I/O pin can be used to operate as the output of an amplifier driving an external crystal and bias circuitry.

XTL2

This user I/O pin can be used as the input of an amplifier connected to an external crystal and bias circuitry. The I/O Block is left unconfigured. The oscillator configuration is activated by routing a net from the oscillator buffer symbol output and by the MAKEBITS program.

CS0, CS1, CS2, WS

These four inputs represent a set of signals, three active low and one active high, which are used in the Peripheral mode to control configuration data entry. The assertion of all 4 generates a write to the internal data buffer. The removal of any assertion, clocks in the D0-D7 data present.

RCLK

During Master parallel mode configuration $\overline{\text{RCLK}}$ represents a "read" of an external dynamic memory device (normally not used).

RDY/BUSY

During Peripheral parallel mode configuration this pin indicates when the chip is ready for another byte of data to be written to it. After configuration is complete, this pin becomes a user programmed I/O pin.

D0-D7

This set of 8 pins represent the parallel configuration byte for the parallel Master and Peripheral modes. After configuration is complete they are user programmed I/O pin.

A0-A15

This set of 16 pins present an address output for a configuration EPROM during Master parallel mode. After configuration is complete they are user programmed I/O pin.

DIN

This user I/O pin is used as serial Data input during Slave or Master Serial configuration. This pin is Data 0 input in Master or Peripheral configuration mode.

DOUT

This user I/O pin is used during configuration to output serial configuration data for daisy-chained slaves' Data In.

TCLKIN

This is a direct CMOS level input to the global clock buffer.

3. Unrestricted User I/O Pins.

I/O

A pin which may be programmed by the user to be Input and/or Output pin following configuration. Some of these pins present a high impedance pull-up (see next page) or perform other functions before configuration is complete (see above).

Table 2a. ATT3000 Family Configuration Pin Assignments

| Configuration Mode: <M2:M1:M0> | | | | | 44 | 68 | 94 | 84 | 100 | 100 | User |
|--------------------------------|-----------------------|-----------------------|------------------------|-----------------------|------|------|------|-----|------|------|-------------|
| Slave <1:1:1> | Master-SER <0:0:0> | Peripheral <1:0:1> | Master-High <1:0:1> | Master-Low <1:0:0> | PLCC | PLCC | PLCC | PGA | POFP | COFP | Operation |
| PWR DWN (I) | PWR DWN (I) | PWR DWN (I) | PWR DWN (I) | PWR DWN (I) | 7 | 10 | 12 | B2 | 29 | 14 | PWR DWN (I) |
| VCC | VCC | VCC | VCC | VCC | 12 | 18 | 22 | F3 | 41 | 26 | VCC |
| M1 (HIGH) (I) | M1 (LOW) (I) | M1 (LOW) (I) | M1 (HIGH) (I) | M1 (LOW) (I) | 16 | 25 | 31 | J2 | 52 | 37 | RDATA |
| M0 (HIGH) (I) | M0 (LOW) (I) | M0 (HIGH) (I) | M0 (LOW) (I) | M0 (LOW) (I) | 17 | 26 | 32 | L1 | 54 | 39 | RTRIG (I) |
| M2 (HIGH) (I) | M2 (LOW) (I) | M2 (HIGH) (I) | M2 (HIGH) (I) | M2 (HIGH) (I) | 18 | 27 | 33 | K2 | 56 | 41 | I/O |
| HDC(HIGH) | HDC(HIGH) | HDC(HIGH) | HDC(HIGH) | HDC(HIGH) | 19 | 28 | 34 | K3 | 57 | 42 | I/O |
| LDC (LOW) | LDC (LOW) | LDC (LOW) | LDC (LOW) | LDC (LOW) | 20 | 30 | 36 | L3 | 59 | 44 | I/O |
| INIT * | INIT * | INIT * | INIT * | INIT * | 22 | 34 | 42 | K6 | 65 | 50 | I/O |
| GND | GND | GND | GND | GND | 23 | 35 | 43 | J6 | 66 | 51 | GND |
| RESET (I) | RESET (I) | RESET (I) | RESET (I) | RESET (I) | 26 | 43 | 53 | L11 | 76 | 61 | XTL2 - I/O |
| DONE | DONE | DONE | DONE | DONE | 27 | 44 | 54 | K10 | 78 | 63 | RESET (I) |
| | | DATA 7 (I) | DATA 7 (I) | DATA 7 (I) | 28 | 45 | 55 | J10 | 80 | 65 | PROG (I) |
| | | | | | 46 | 56 | K11 | 81 | 66 | | I/O |
| | | | | | 30 | 47 | 57 | J11 | 82 | 67 | XTL1 - I/O |
| | | DATA 6 (I) | DATA 6 (I) | DATA 6 (I) | 48 | 58 | H10 | 83 | 68 | | I/O |
| | | DATA 5 (I) | DATA 5 (I) | DATA 5 (I) | 49 | 60 | F10 | 87 | 72 | | I/O |
| | | CS0 (I) | | | 50 | 61 | G10 | 88 | 73 | | I/O |
| | | DATA 4 (I) | DATA 4 (I) | DATA 4 (I) | 51 | 62 | G11 | 89 | 74 | | I/O |
| VCC | VCC | VCC | VCC | VCC | 34 | 52 | 64 | F9 | 91 | 76 | VCC |
| | | DATA 3 (I) | DATA 3 (I) | DATA 3 (I) | 53 | 65 | F11 | 92 | 77 | | I/O |
| | | CS1 (I) | | | 54 | 66 | E11 | 93 | 78 | | I/O |
| | | DATA 2 (I) | DATA 2 (I) | DATA 2 (I) | 55 | 67 | E10 | 94 | 79 | | I/O |
| | | DATA 1 (I) | DATA 1 (I) | DATA 1 (I) | 56 | 70 | D10 | 98 | 83 | | I/O |
| | | RDY/ BUSY | RCLK | RCLK | 57 | 71 | C11 | 99 | 84 | | I/O |
| DIN (I) | DIN (I) | DATA 0 (I) | DATA 0 (I) | DATA 0 (I) | 38 | 58 | 72 | B11 | 100 | 85 | I/O |
| DOUT (I) | DOUT (I) | DOUT (I) | DOUT (I) | DOUT (I) | 39 | 59 | 73 | C10 | 1 | 86 | I/O |
| CCLK (I) | CCLK | CCLK | CCLK | CCLK | 40 | 60 | 74 | A11 | 2 | 87 | CCLK (I) |
| | | WS (I) | A0 | A0 | 61 | 75 | B10 | 5 | 90 | | I/O |
| | | CS2 (I) | A1 | A1 | 62 | 76 | B9 | 6 | 91 | | I/O |
| | | | A2 | A2 | 63 | 77 | A10 | 8 | 93 | | I/O |
| | | | A3 | A3 | 64 | 78 | A9 | 9 | 94 | | I/O |
| | | | A15 | A15 | 65 | 81 | B6 | 12 | 97 | | I/O |
| | | | A4 | A4 | 66 | 82 | B7 | 13 | 98 | | I/O |
| | | | A14 | A14 | 67 | 83 | A7 | 14 | 99 | | I/O |
| | | | A5 | A5 | 68 | 84 | C7 | 15 | 100 | | I/O |
| GND | GND | GND | GND | GND | 1 | 1 | 1 | C6 | 16 | 1 | GND |
| | | | A13 | A13 | 2 | 2 | A6 | 17 | 2 | | I/O |
| | | | A6 | A6 | 3 | 3 | A5 | 18 | 3 | | I/O |
| | | | A12 | A12 | 4 | 4 | B5 | 19 | 4 | | I/O |
| | | | A7 | A7 | 5 | 5 | C5 | 20 | 5 | | I/O |
| | | | A11 | A11 | 6 | 6 | A3 | 23 | 8 | | I/O |
| | | | A8 | A8 | 7 | 7 | A2 | 24 | 9 | | I/O |
| | | | A10 | A10 | 8 | 8 | B3 | 25 | 10 | | I/O |
| | | | A9 | A9 | 9 | 9 | A1 | 26 | 11 | | I/O |
| | | | | | X | X | X | X | X | | ATT3020 |
| | | | | | X | X | X | X | X | | ATT3030 |
| | | | | | | | X | X | X | | ATT3042 |
| | | | | | | | X** | | | | ATT3064 |
| | | | | | | | X** | | | | ATT3090 |

REPRESENTS A 50 kΩ TO 100 kΩ PULL-UP.

* INIT IS AN OPEN DRAIN OUTPUT DURING CONFIGURATION.

(I) REPRESENTS AN INPUT


** PIN ASSIGNMENTS FOR THE ATT3064/ATT3090 DIFFER FROM THOSE SHOWN, SEE PAGE 35.

*** PERIPHERAL MODE AND MASTER PARALLEL MODE ARE NOT SUPPORTED IN THE 44 PLCC PACKAGE, SEE PAGE 33.

Note: Pin assignments of "PGA Footprint" PLCC sockets and PGA packages are not electrically identical. Generic I/O pins are not shown.

Table 2a. ATT3000 Family Configuration Pin Assignments (continued)

| Configuration Mode: <M2:M1:M0> | | | | | 100 | 132 | 160 | 184 | 175 | 208 | User |
|--------------------------------|-----------------------|-----------------------|------------------------|-----------------------|------|-----|------|------|-----|-----|-------------|
| Slave <1:1:1> | Master-SER <0:0:0> | Peripheral <1:0:1> | Master-High <1:1:0> | Master-Low <1:0:0> | SQFP | PGA | PQFP | CQFP | PGA | QFP | Operation |
| PWR DWN (I) | PWR DWN (I) | PWR DWN (I) | PWR DWN (I) | PWR DWN (I) | 26 | A1 | 159 | 20 | B2 | 3 | PWR DWN (I) |
| VCC | VCC | VCC | VCC | VCC | 38 | C8 | 20 | 42 | D9 | 26 | VCC |
| M1 (HIGH) (I) | M1 (LOW) (I) | M1 (LOW) (I) | M1 (HIGH) (I) | M1 (LOW) (I) | 49 | B13 | 40 | 62 | B14 | 48 | RDATA |
| M0 (HIGH) (I) | M0 (LOW) (I) | M0 (HIGH) (I) | M0 (LOW) (I) | M0 (LOW) (I) | 51 | A14 | 42 | 64 | B15 | 50 | RTRIG (I) |
| M2 (HIGH) (I) | M2 (LOW) (I) | M2 (HIGH) (I) | M2 (HIGH) (I) | M2 (HIGH) (I) | 53 | C13 | 44 | 66 | C15 | 56 | I/O |
| HDC(HIGH) | HDC(HIGH) | HDC(HIGH) | HDC(HIGH) | HDC(HIGH) | 54 | B14 | 45 | 67 | E14 | 57 | I/O |
| LDC (LOW) | LDC (LOW) | LDC (LOW) | LDC (LOW) | LDC (LOW) | 56 | D14 | 49 | 71 | D16 | 61 | I/O |
| INIT * | INIT * | INIT * | INIT * | INIT * | 62 | G14 | 59 | 81 | H15 | 77 | I/O |
| GND | GND | GND | GND | GND | 63 | H12 | 19 | 83 | J14 | 25 | GND |
| | | | | | 73 | M13 | 76 | 99 | P15 | 100 | XTL2 - I/O |
| RESET (I) | RESET (I) | RESET (I) | RESET (I) | RESET (I) | 75 | P14 | 78 | 101 | R15 | 102 | RESET (I) |
| DONE | DONE | DONE | DONE | DONE | 77 | N13 | 80 | 103 | R14 | 107 | PROG (I) |
| | | DATA 7 (I) | DATA 7 (I) | DATA 7 (I) | 78 | M12 | 81 | 104 | N13 | 109 | I/O |
| | | | | | 79 | P13 | 82 | 105 | T14 | 110 | XTL1 - I/O |
| | | DATA 6 (I) | DATA 6 (I) | DATA 6 (I) | 80 | N11 | 86 | 109 | P12 | 115 | I/O |
| | | DATA 5 (I) | DATA 5 (I) | DATA 5 (I) | 84 | M9 | 92 | 115 | T11 | 122 | I/O |
| | | CS0 (I) | | | 85 | N9 | 93 | 116 | R10 | 123 | I/O |
| | | DATA 4 (I) | DATA 4 (I) | DATA 4 (I) | 86 | N8 | 98 | 121 | R9 | 128 | I/O |
| VCC | VCC | VCC | VCC | VCC | 88 | M8 | 100 | 123 | N8 | 130 | VCC |
| | | DATA 3 (I) | DATA 3 (I) | DATA 3 (I) | 89 | N7 | 102 | 125 | P8 | 132 | I/O |
| | | CS1 (I) | | | 90 | P6 | 103 | 126 | R8 | 133 | I/O |
| | | DATA 2 (I) | DATA 2 (I) | DATA 2 (I) | 91 | M6 | 108 | 131 | R7 | 138 | I/O |
| | | DATA 1 (I) | DATA 1 (I) | DATA 1 (I) | 95 | M5 | 114 | 137 | R5 | 145 | I/O |
| | | RDY/ BUSY | RCLK | RCLK | 96 | N4 | 115 | 138 | P5 | 146 | I/O |
| DIN (I) | DIN (I) | DATA 0 (I) | DATA 0 (I) | DATA 0 (I) | 97 | N2 | 119 | 143 | R3 | 151 | I/O |
| DOUT (I) | DOUT (I) | DOUT (I) | DOUT (I) | DOUT (I) | 98 | M3 | 120 | 144 | N4 | 152 | I/O |
| CCLK (I) | CCLK | CCLK | CCLK | CCLK | 99 | P1 | 121 | 145 | R2 | 153 | CCLK (I) |
| | | WS (I) | A0 | A0 | 2 | M2 | 124 | 148 | P2 | 161 | I/O |
| | | CS2 (I) | A1 | A1 | 3 | N1 | 125 | 149 | M3 | 162 | I/O |
| | | | A2 | A2 | 5 | L2 | 128 | 152 | P1 | 165 | I/O |
| | | | A3 | A3 | 6 | L1 | 129 | 153 | N1 | 166 | I/O |
| | | | A15 | A15 | 9 | K1 | 132 | 156 | M1 | 172 | I/O |
| | | | A4 | A4 | 10 | J2 | 133 | 157 | L2 | 173 | I/O |
| | | | A14 | A14 | 11 | H1 | 136 | 160 | K2 | 178 | I/O |
| | | | A5 | A5 | 12 | H2 | 137 | 161 | K1 | 179 | I/O |
| GND | GND | GND | GND | GND | 13 | H3 | 139 | 164 | J3 | 182 | GND |
| | | | A13 | A13 | 14 | G2 | 141 | 2 | H2 | 184 | I/O |
| | | | A6 | A6 | 15 | G1 | 142 | 3 | H1 | 185 | I/O |
| | | | A12 | A12 | 16 | F2 | 147 | 8 | F2 | 192 | I/O |
| | | | A7 | A7 | 17 | E1 | 148 | 9 | E1 | 193 | I/O |
| | | | A11 | A11 | 20 | D1 | 151 | 12 | D1 | 199 | I/O |
| | | | A8 | A8 | 21 | D2 | 152 | 13 | C1 | 200 | I/O |
| | | | A10 | A10 | 22 | B1 | 155 | 16 | E3 | 203 | I/O |
| | | | A9 | A9 | 23 | C2 | 156 | 17 | C2 | 204 | I/O |
| | | | | | | | | | | | ATT3020 |
| | | | | | X | | | | | | ATT3030 |
| | | | | | X | X | | | | | ATT3042 |
| | | | | | | X | X | | | | ATT3064 |
| | | | | | | | X | X | X | X | ATT3090 |

 REPRESENTS A 50 kΩ TO 100 kΩ PULL-UP.
 * INIT IS AN OPEN DRAIN OUTPUT DURING CONFIGURATION.
 (I) REPRESENTS AN INPUT

Note: Pin assignments of "PGA Footprint" PLCC sockets and PGA packages are not electrically identical. Generic I/O pins are not shown.

Table 2b. ATT3000 44-Pin PLCC Pinout

| 44 PLCC | ATT3030 | 44 PLCC | ATT3030 |
|---------|------------|---------|------------------|
| 1 | GND | 23 | GND |
| 2 | I/O | 24 | I/O |
| 3 | I/O | 25 | I/O |
| 4 | I/O | 26 | XTL2(IN)-I/O |
| 5 | I/O | 27 | RESET |
| 6 | I/O | 28 | DONE- PROG |
| 7 | PWRDWN | 29 | I/O |
| 8 | TCLKIN-I/O | 30 | XTL1(OUT)-BCLKIN |
| 9 | I/O | 31 | I/O |
| 10 | I/O | 32 | I/O |
| 11 | I/O | 33 | I/O |
| 12 | Vcc | 34 | Vcc |
| 13 | I/O | 35 | I/O |
| 14 | I/O | 36 | I/O |
| 15 | I/O | 37 | I/O |
| 16 | M1- RDATA | 38 | DIN-I/O |
| 17 | M0-RTRIG | 39 | DOUT-I/O |
| 18 | M2-I/O | 40 | CCLK |
| 19 | HDC-I/O | 41 | I/O |
| 20 | LDC -I/O | 42 | I/O |
| 21 | I/O | 43 | I/O |
| 22 | INIT -I/O | 44 | I/O |

Notes:

Peripheral Mode and Master Parallel Mode are not supported in the M44 Package.
Parallel address and data pins are not assigned.

ATT3000 Series Field-Programmable Gate Arrays

Table 2c. ATT3000 Family 68-Pin PLCC, 84-Pin PLCC Pinouts, and 84-Pin PGA Pinouts

| 68 PLCC | ATT3020 ATT3030, ATT3042 | 84 PLCC | 84 PGA | 68 PLCC | ATT3020 ATT3030, ATT3042 | 84 PLCC | 84 PGA |
|------------|-----------------------------|------------|-----------|------------|-----------------------------|------------|-----------|
| 10 | PWRDN | 12 | B2 | 44 | RESET | 54 | K10 |
| 11 | TCLKIN-I/O | 13 | C2 | 45 | DONE- PROG | 55 | J10 |
| — | I/O* | 14 | B1 | 46 | D7-I/O | 56 | K11 |
| 12 | I/O | 15 | C1 | 47 | XTL1(OUT)-BCLKIN-I/O | 57 | J11 |
| 13 | I/O | 16 | D2 | 48 | D6-I/O | 58 | H10 |
| — | I/O | 17 | D1 | — | I/O | 59 | H11 |
| 14 | I/O | 18 | E3 | 49 | D5-I/O | 60 | F10 |
| 15 | I/O | 19 | E2 | 50 | CS0 -I/O | 61 | G10 |
| 16 | I/O | 20 | E1 | 51 | D4-I/O | 62 | G11 |
| 17 | I/O | 21 | F2 | — | I/O | 63 | G9 |
| 18 | Vcc | 22 | F3 | 52 | Vcc | 64 | F9 |
| 19 | I/O | 23 | G3 | 53 | D3-I/O | 65 | F11 |
| — | I/O | 24 | G1 | 54 | CS1 -I/O | 66 | E11 |
| 20 | I/O | 25 | G2 | 55 | D2-I/O | 67 | E10 |
| 21 | I/O | 26 | F1 | — | I/O | 68 | E9 |
| 22 | I/O | 27 | H1 | — | I/O* | 69 | D11 |
| — | I/O | 28 | H2 | 56 | D1-I/O | 70 | D10 |
| 23 | I/O | 29 | J1 | 57 | RDY/ BUSY - RCLK -I/O | 71 | C11 |
| 24 | I/O | 30 | K1 | 58 | D0-DIN-I/O | 72 | B11 |
| 25 | M1- RDATA | 31 | J2 | 59 | DOUT-I/O | 73 | C10 |
| 26 | M0-RTRIG | 32 | L1 | 60 | CCLK | 74 | A11 |
| 27 | M2-I/O | 33 | K2 | 61 | A0- WS -I/O | 75 | B10 |
| 28 | HDC-I/O | 34 | K3 | 62 | A1-CS2-I/O | 76 | B9 |
| 29 | I/O | 35 | L2 | 63 | A2-I/O | 77 | A10 |
| 30 | LDC -I/O | 36 | L3 | 64 | A3-I/O | 78 | A9 |
| 31 | I/O | 37 | K4 | — | I/O* | 79 | B8 |
| — | I/O* | 38 | L4 | — | I/O* | 80 | A8 |
| 32 | I/O | 39 | J5 | 65 | A15-I/O | 81 | B6 |
| 33 | I/O | 40 | K5 | 66 | A4-I/O | 82 | B7 |
| — | I/O* | 41 | L5 | 67 | A14-I/O | 83 | A7 |
| 34 | INIT -I/O | 42 | K6 | 68 | A5-I/O | 84 | C7 |
| 35 | GND | 43 | J6 | 1 | GND | 1 | C6 |
| 36 | I/O | 44 | J7 | 2 | A13-I/O | 2 | A6 |
| 37 | I/O | 45 | L7 | 3 | A6-I/O | 3 | A5 |
| 38 | I/O | 46 | K7 | 4 | A12-I/O | 4 | B5 |
| 39 | I/O | 47 | L6 | 5 | A7-I/O | 5 | C5 |
| 40 | I/O | 48 | L8 | — | I/O* | 6 | A4 |
| 41 | I/O | 49 | K8 | — | I/O* | 7 | B4 |
| — | I/O* | 50 | L9 | 6 | A11-I/O | 8 | A3 |
| — | I/O* | 51 | L10 | 7 | A8-I/O | 9 | A2 |
| 42 | I/O | 52 | K9 | 8 | A10-I/O | 10 | B3 |
| 43 | XTL2(IN)-I/O | 53 | L11 | 9 | A9-I/O | 11 | A1 |

* Indicates unconnected package pins for the ATT3020.

Note: Unprogrammed IOBs have a default pull-up. This prevents an undefined pad level for unbonded or unused IOBs.
Programmed outputs are default slew-limited.

Table 2d. ATT3064 /ATT3090 84-Pin PLCC Pinouts

| PLCC Pin Number | ATT3064 ATT3090 | PLCC Pin Number | ATT3064 ATT3090 |
|--------------------|--------------------|--------------------|-----------------------|
| 12 | PWRDN | 54 | RESET |
| 13 | TCLKIN-I/O | 55 | DONE- PROG |
| 14 | I/O | 56 | D7-I/O |
| 15 | I/O | 57 | XTL1(OUT)-BCLKIN-I/O |
| 16 | I/O | 58 | D6-I/O |
| 17 | I/O | 59 | I/O |
| 18 | I/O | 60 | D5-I/O |
| 19 | I/O | 61 | CS0 -I/O |
| 20 | I/O | 62 | D4-I/O |
| 21 | GND* | 63 | I/O |
| 22 | Vcc | 64 | Vcc |
| 23 | I/O | 65 | GND* |
| 24 | I/O | 66 | D3 -I/O* |
| 25 | I/O | 67 | CS1-I/O* |
| 26 | I/O | 68 | D2-I/O* |
| 27 | I/O | 69 | I/O |
| 28 | I/O | 70 | D1-I/O |
| 29 | I/O | 71 | RDY/ BUSY - RCLK -I/O |
| 30 | I/O | 72 | D0-DIN-I/O |
| 31 | M1- RDATA | 73 | DOUT-I/O |
| 32 | M0-RTRIG | 74 | CCLK |
| 33 | M2-I/O | 75 | A0- WS -I/O |
| 34 | HDC-I/O | 76 | A1-CS2-I/O |
| 35 | I/O | 77 | A2-I/O |
| 36 | LDC -I/O | 78 | A3-I/O |
| 37 | I/O | 76 | I/O |
| 38 | I/O | 80 | I/O |
| 39 | I/O | 81 | A15-I/O |
| 40 | I/O | 82 | A4-I/O |
| 41 | INIT/I/O* | 83 | A14-I/O |
| 42 | Vcc* | 84 | A5-I/O |
| 43 | GND | 1 | GND |
| 44 | I/O | 2 | Vcc* |
| 45 | I/O | 3 | A13-I/O* |
| 46 | I/O | 4 | A6-I/O* |
| 47 | I/O | 5 | A12-I/O* |
| 48 | I/O | 6 | A7-I/O* |
| 49 | I/O | 7 | I/O |
| 50 | I/O | 8 | A11-I/O |
| 51 | I/O | 9 | A8-I/O |
| 52 | I/O | 10 | A10-I/O |
| 53 | XTL2(IN)-I/O | 11 | A9-I/O |

* Different pin definition than 3020/3030/3042 PC84 package.

Note: Unprogrammed IOBs have a default pull-up. This prevents an undefined pad level for unbonded or unused IOBs.
Programmed outputs are default slew-limited. DEVICE POWER MUST BE LESS THAN 1 WATT.

Table 2e. ATT3000 Family 100-Pin QFP Pinouts

| Pin Number | | ATT3020 ATT3030 ATT3042 | Pin Number | | ATT3020 ATT3030 ATT3042 | Pin Number | | ATT3020 ATT3030 ATT3042 |
|------------|------|-------------------------------|------------|------|-------------------------------|------------|------|-------------------------------|
| CQFP | PQFP | | CQFP | PQFP | | CQFP | PQFP | |
| 1 | 16 | GND | 35* | 50* | I/O | 69* | 84* | I/O |
| 2 | 17 | A13-I/O | 36* | 51* | I/O | 70* | 85* | I/O |
| 3 | 18 | A6-I/O | 37 | 52 | M1- RD | 71 | 86 | I/O |
| 4 | 19 | A12-I/O | 38 | 53* | GND | 72 | 87 | D5-I/O |
| 5 | 20 | A7-I/O | 39 | 54 | M0-RT | 73 | 88 | CS0 -I/O |
| 6* | 21* | I/O | 40 | 55* | Vcc | 74 | 89 | D4-I/O |
| 7* | 22* | I/O | 41 | 56 | M2-I/O | 75 | 90 | I/O |
| 8 | 23 | A11-I/O | 42 | 57 | HDC-I/O | 76 | 91 | Vcc |
| 9 | 24 | A8-I/O | 43 | 58 | I/O | 77 | 92 | D3-I/O |
| 10 | 25 | A10-I/O | 44 | 59 | LDC -I/O | 78 | 93 | CS1 -I/O |
| 11 | 26 | A9-I/O | 45* | 60* | I/O | 79 | 94 | D2-I/O |
| 12 | 27* | Vcc | 46* | 61* | I/O | 80 | 95 | I/O |
| 13 | 28* | GND | 47 | 62 | I/O | 81* | 96* | I/O |
| 14 | 29 | PWRDN | 48 | 63 | I/O | 82* | 97* | I/O |
| 15 | 30 | TCLKIN-I/O | 49 | 64 | I/O | 83 | 98 | D1-I/O |
| 16* | 31* | I/O | 50 | 65 | INIT -I/O | 84 | 99 | RCLK - BUSY /RDY-I/O |
| 17* | 32* | I/O | 51 | 66 | GND | 85 | 100 | D0-DIN-I/O |
| 18* | 33* | I/O | 52 | 67 | I/O | 86 | 1 | DOUT-I/O |
| 19 | 34 | I/O | 53 | 68 | I/O | 87 | 2 | CCLK |
| 20 | 35 | I/O | 54 | 69 | I/O | 88 | 3* | Vcc |
| 21 | 36 | I/O | 55 | 70 | I/O | 89 | 4* | GND |
| 22 | 37 | I/O | 56 | 71 | I/O | 90 | 5 | A0- WS -I/O |
| 23 | 38 | I/O | 57 | 72 | I/O | 91 | 6 | A1-CS2-I/O |
| 24 | 39 | I/O | 58 | 73 | I/O | 92* | 7* | I/O |
| 25 | 40 | I/O | 59* | 74* | I/O | 93 | 8 | A2-I/O |
| 26 | 41 | Vcc | 60* | 75* | I/O | 94 | 9 | A3-I/O |
| 27 | 42 | I/O | 61 | 76 | XTAL2-I/O | 95* | 10* | I/O |
| 28 | 43 | I/O | 62 | 77* | GND | 96* | 11* | I/O |
| 29 | 44 | I/O | 63 | 78 | RESET | 97 | 12 | A15-I/O |
| 30 | 45 | I/O | 64 | 79* | Vcc | 98 | 13 | A4-I/O |
| 31 | 46 | I/O | 65 | 80 | DONE- PG | 99 | 14 | A14-I/O |
| 32 | 47 | I/O | 66 | 81 | D7-I/O | 100 | 15 | A5-I/O |
| 33 | 48 | I/O | 67 | 82 | XTAL1-BCLKIN-I/O | | | |
| 34 | 49 | I/O | 68 | 83 | D6-I/O | | | |

* This table describes the pinouts of three different chips in two different packages. The third column lists 100 of the 118 pads on the ATT3042 that are connected to the 100 package pins. Two pads, indicated by double asterisks, do not exist on the ATT3030, which has 98 pads; therefore the corresponding pins have no connections. Twenty-six pads, indicated by single or double asterisks, do not exist on the ATT3020, which has 74 pads; therefore, the corresponding pins have no connections. (See Table 2c.)

Note: Unprogrammed IOBs have a default pull-up. This prevents an undefined pad level for unbonded or unused IOBs.
 Programmed outputs are default slew-limited.
 The 3030 is not available in a 100-pin CQFP.

Table 2f. ATT3000 Family 100-Pin SQFP Pinouts

| Pin Number SQFP | ATT3020 ATT3030 ATT3042 | Pin Number SQFP | ATT3020 ATT3030 ATT3042 | Pin Number SQFP | ATT3020 ATT3030 ATT3042 |
|--------------------|-------------------------------|--------------------|-------------------------------|--------------------|-------------------------------|
| 16 | GND | 50 | I/O | 84 | I/O |
| 17 | A13-I/O | 51 | I/O | 85 | I/O |
| 18 | A6-I/O | 52 | M1- RD | 86 | I/O |
| 19 | A12-I/O | 53 | GND | 87 | D5-I/O |
| 20 | A7-I/O | 54 | M0-RT | 88 | CS0 -I/O |
| 21 | I/O | 55 | Vcc | 89 | D4-I/O |
| 22 | I/O | 56 | M2-I/O | 90 | I/O |
| 23 | A11-I/O | 57 | HDC-I/O | 91 | Vcc |
| 24 | A8-I/O | 58 | I/O | 92 | D3-I/O |
| 25 | A10-I/O | 59 | LDC -I/O | 93 | CS1 -I/O |
| 26 | A9-I/O | 60 | I/O | 94 | D2-I/O |
| 27 | Vcc | 61 | I/O | 95 | I/O |
| 28 | GND | 62 | I/O | 96* | I/O |
| 29 | PWRDN | 63 | I/O | 97 | I/O |
| 30 | TCLKIN-I/O | 64 | I/O | 98 | D1-I/O |
| 31 | I/O | 65 | INIT -I/O | 99 | RCLK - BUSY /RDY-I/O |
| 32 | I/O | 66 | GND | 100 | D0-DIN-I/O |
| 33 | I/O | 67 | I/O | 1 | DOUT-I/O |
| 34 | I/O | 68 | I/O | 2 | CCLK |
| 35 | I/O | 69 | I/O | 3 | Vcc |
| 36 | I/O | 70 | I/O | 4 | GND |
| 37 | I/O | 71 | I/O | 5 | A0- WS -I/O |
| 38 | I/O | 72 | I/O | 6 | A1-CS2-I/O |
| 39 | I/O | 73 | I/O | 7 | I/O |
| 40 | I/O | 74 | I/O | 8 | A2-I/O |
| 41 | Vcc | 75 | I/O | 9 | A3-I/O |
| 42 | I/O | 76 | XTAL2-I/O | 10 | I/O |
| 43 | I/O | 77 | GND | 11 | I/O |
| 44 | I/O | 78 | RESET | 12 | A15-I/O |
| 45 | I/O | 79 | Vcc | 13 | A4-I/O |
| 46 | I/O | 80 | DONE- PG | 14 | A14-I/O |
| 47 | I/O | 81 | D7-I/O | 15 | A5-I/O |
| 48 | I/O | 82 | XTAL1-BCLKIN-I/O | | |
| 49 | I/O | 83 | D6-I/O | | |

☐ = Preliminary.

Note: Unprogrammed IOBs have a default pull-up. This prevents an undefined pad level for unbonded or unused IOBs. Programmed outputs are default slew-limited.

ATT3000 Series Field-Programmable Gate Arrays

Table 2g. ATT3000 Family 132-Pin PGA Pinouts

| PGA Pin Number | ATT3042 ATT3064 | PGA Pin Number | ATT3042 ATT3064 | PGA Pin Number | ATT3042 ATT3064 | PGA Pin Number | ATT3042 ATT3064 |
|----------------|--------------------|----------------|--------------------|----------------|----------------------|----------------|--------------------|
| C4 | GND | B13 | M1- RD | P14 | RESET | M3 | DOUT-I/O |
| A1 | PWRDN | C11 | GND | M11 | Vcc | P1 | CCLK |
| C3 | TCLKIN-I/O | A14 | M0-RT | N13 | DONE- PG | M4 | Vcc |
| B2 | I/O | D12 | Vcc | M12 | D7-I/O | L3 | GND |
| B3 | I/O | C13 | M2-I/O | P13 | XTAL1-BCLKIN-I/O | M2 | A0- WS -I/O |
| A2 | I/O* | B14 | HDC-I/O | N12 | I/O | N1 | A1-CS2-I/O |
| B4 | I/O | C14 | I/O | P12 | I/O | M1 | I/O |
| C5 | I/O | E12 | I/O | N11 | D6-I/O | K3 | I/O |
| A3 | I/O* | D13 | I/O | M10 | I/O | L2 | A2-I/O |
| A4 | I/O | D14 | LDC -I/O | P11 | I/O* | L1 | A3-I/O |
| B5 | I/O | E13 | I/O* | N10 | I/O | K2 | I/O |
| C6 | I/O | F12 | I/O | P10 | I/O | J3 | I/O |
| A5 | I/O | E14 | I/O | M9 | D5-I/O | K1 | A15-I/O |
| B6 | I/O | F13 | I/O | N9 | CSO -I/O | J2 | A4-I/O |
| A6 | I/O | F14 | I/O | P9 | I/O* | J1 | I/O* |
| B7 | I/O | G13 | I/O | P8 | I/O* | H1 | A14-I/O |
| C7 | GND | G14 | INIT -I/O | N8 | D4-I/O | H2 | A5-I/O |
| C8 | Vcc | G12 | Vcc | P7 | I/O | H3 | GND |
| A7 | I/O | H12 | GND | M8 | Vcc | G3 | Vcc |
| B8 | I/O | H14 | I/O | M7 | GND | G2 | A13-I/O |
| A8 | I/O | H13 | I/O | N7 | D3-I/O | G1 | A6-I/O |
| A9 | I/O | J14 | I/O | P6 | CS1 -I/O | F1 | I/O* |
| B9 | I/O | J13 | I/O | N6 | I/O* | F2 | A12-I/O |
| C9 | I/O | K14 | I/O | P5 | I/O* | E1 | A7-I/O |
| A10 | I/O | J12 | I/O | M6 | D2-I/O | F3 | I/O |
| B10 | I/O | K13 | I/O | N5 | I/O | E2 | I/O |
| A11 | I/O* | L14 | I/O* | P4 | I/O | D1 | A11-I/O |
| C10 | I/O | L13 | I/O | P3 | I/O | D2 | A8-I/O |
| B11 | I/O | K12 | I/O | M5 | D1-I/O | E3 | I/O |
| A12 | I/O* | M14 | I/O | N4 | RCLK - BUSY /RDY-I/O | C1 | I/O |
| B12 | I/O | N14 | I/O | P2 | I/O | B1 | A10-I/O |
| A13 | I/O* | M13 | XTAL2(IN)-I/O | N3 | I/O | C2 | A9-I/O |
| C12 | I/O | L12 | GND | N2 | D0-DIN-I/O | D3 | Vcc |

* Indicates unconnected package pins for the ATT3042.

Note: Unprogrammed IOBs have a default pull-up. This prevents an undefined pad level for unbonded or unused IOBs. Programmed outputs are default slew-limited.

Table 2h. ATT3000 Family 160-Pin PQFP Pinout

| PQFP Pin No. | ATT3064 ATT3090 | PQFP Pin No. | ATT3064 ATT3090 | PQFP Pin No. | ATT3064 ATT3090 | PQFP Pin No. | ATT3064 ATT3090 |
|-----------------|--------------------|-----------------|--------------------|-----------------|----------------------|-----------------|--------------------|
| 1 | I/O* | 41 | GND | 81 | D7-I/O | 121 | CCLK |
| 2 | I/O* | 42 | M0-RTRIG | 82 | XTAL1-BCLKIN-I/O | 122 | Vcc |
| 3 | I/O* | 43 | VCC | 83 | I/O* | 123 | GND |
| 4 | I/O | 44 | M2-I/O | 84 | I/O | 124 | A0- WS -I/O |
| 5 | I/O | 45 | HDC-I/O | 85 | I/O | 125 | A1-CS2-I/O |
| 6 | I/O | 46 | I/O | 86 | D6-I/O | 126 | I/O |
| 7 | I/O | 47 | I/O | 87 | I/O | 127 | I/O |
| 8 | I/O | 48 | I/O | 88 | I/O | 128 | A2-I/O |
| 9 | I/O | 49 | LDC -I/O | 89 | I/O | 129 | A3-I/O |
| 10 | I/O | 50 | I/O* | 90 | I/O | 130 | I/O |
| 11 | I/O | 51 | I/O* | 91 | I/O | 131 | I/O |
| 12 | I/O | 52 | I/O | 92 | D5-I/O | 132 | A15-I/O |
| 13 | I/O | 53 | I/O | 93 | CS0 -I/O | 133 | A4-I/O |
| 14 | I/O | 54 | I/O | 94 | I/O* | 134 | I/O |
| 15 | I/O | 55 | I/O | 95 | I/O* | 135 | I/O |
| 16 | I/O | 56 | I/O | 96 | I/O | 136 | A14-I/O |
| 17 | I/O | 57 | I/O | 97 | I/O | 137 | A5-I/O |
| 18 | I/O | 58 | I/O | 98 | D4-I/O | 138 | I/O* |
| 19 | GND | 59 | INIT -I/O | 99 | I/O | 139 | GND |
| 20 | Vcc | 60 | Vcc | 100 | Vcc | 140 | Vcc |
| 21 | I/O* | 61 | GND | 101 | GND | 141 | A13-I/O |
| 22 | I/O | 62 | I/O | 102 | D3-I/O | 142 | A6-I/O |
| 23 | I/O | 63 | I/O | 103 | CS1 -I/O | 143 | I/O* |
| 24 | I/O | 64 | I/O | 104 | I/O | 144 | I/O* |
| 25 | I/O | 65 | I/O | 105 | I/O | 145 | I/O |
| 26 | I/O | 66 | I/O | 106 | I/O* | 146 | I/O |
| 27 | I/O | 67 | I/O | 107 | I/O* | 147 | A12-I/O |
| 28 | I/O | 68 | I/O | 108 | D2-I/O | 148 | A7-I/O |
| 29 | I/O | 69 | I/O | 109 | I/O | 149 | I/O |
| 30 | I/O | 70 | I/O | 110 | I/O | 150 | I/O |
| 31 | I/O | 71 | I/O | 111 | I/O | 151 | A11-I/O |
| 32 | I/O | 72 | I/O | 112 | I/O | 152 | A8-I/O |
| 33 | I/O | 73 | I/O | 113 | I/O | 153 | I/O |
| 34 | I/O | 74 | I/O | 114 | D1-I/O | 154 | I/O |
| 35 | I/O | 75 | I/O* | 115 | RDY- BSY / RCLK -I/O | 155 | A10-I/O |
| 36 | I/O | 76 | XTAL2-I/O | 116 | I/O | 156 | A9-I/O |
| 37 | I/O | 77 | GND | 117 | I/O | 157 | Vcc |
| 38 | I/O* | 78 | RESET | 118 | I/O* | 158 | GND |
| 39 | I/O* | 79 | Vcc | 119 | D0-DIN-I/O | 159 | PWRDWN |
| 40 | M1- RDATA | 80 | DONE -PROG | 120 | DOUT-I/O | 160 | TCLKIN-I/O |

* Not connected on ATT3064.

Note: Unprogrammed IOBs have a default pull-up. This prevents an undefined pad level for unbonded or unused IOBs.
 Programmed outputs are default slew-limited. DEVICE POWER MUST BE LESS THAN 1 WATT FOR COMMERCIAL
 TEMPERATURE RANGE, AND LESS THAN 0.8 WATTS FOR INDUSTRIAL TEMPERATURE RANGE.

ATT3000 Series Field-Programmable Gate Arrays

Table 2I. ATT3000 Family 164-Pin CQFP Pinouts

| CQFP Pin No. | ATT3090 | CQFP Pin No. | ATT3090 | CQFP Pin No. | ATT3090 | CQFP Pin No. | ATT3090 |
|--------------|------------|--------------|---------------|--------------|-----------------------|--------------|-------------|
| 20 | PWRDWN | 61 | I/O | 103 | DONE- PROG | 143 | D0-DIN-I/O |
| 21 | TCLKIN-I/O | 62 | M1- RDATA | 104 | D7-I/O | 144 | DOUT-I/O |
| 22 | I/O | 63 | GND | 105 | XTAL1(OUT)-BCLKIN-I/O | 145 | CCLK |
| 23 | I/O | 64 | M0-RTRIG | 106 | I/O | 146 | Vcc |
| 24 | I/O | 65 | Vcc | 107 | I/O | 147 | GND |
| 25 | I/O | 66 | M2-I/O | 108 | I/O | 148 | A0- WS -I/O |
| 26 | I/O | 67 | HDC-I/O | 109 | D6-I/O | 149 | A1-CS2-I/O |
| 27 | I/O | 68 | I/O | 110 | I/O | 150 | I/O |
| 28 | I/O | 69 | I/O | 111 | I/O | 151 | I/O |
| 29 | I/O | 70 | I/O | 112 | I/O | 152 | A2-I/O |
| 30 | I/O | 71 | LDC -I/O | 113 | I/O | 153 | A3-I/O |
| 31 | I/O | 72 | I/O | 114 | I/O | 154 | I/O |
| 32 | I/O | 73 | I/O | 115 | D5-I/O | 155 | I/O |
| 33 | I/O | 74 | I/O | 116 | CS0 -I/O | 156 | A15-I/O |
| 34 | I/O | 75 | I/O | 117 | I/O | 157 | A4-I/O |
| 35 | I/O | 76 | I/O | 118 | I/O | 158 | I/O |
| 36 | I/O | 77 | I/O | 119 | I/O | 159 | I/O |
| 37 | I/O | 78 | I/O | 120 | I/O | 160 | A14-I/O |
| 38 | I/O | 79 | I/O | 121 | D4-I/O | 161 | A5-I/O |
| 39 | I/O | 80 | I/O | 122 | I/O | 162 | I/O |
| 40 | I/O | 81 | INIT -I/O | 123 | Vcc | 163 | I/O |
| 41 | GND | 82 | Vcc | 124 | GND | 164 | GND |
| 42 | Vcc | 83 | GND | 125 | D3-I/O | 1 | Vcc |
| 43 | I/O | 84 | I/O | 126 | CS1 -I/O | 2 | A13-I/O |
| 44 | I/O | 85 | I/O | 127 | I/O | 3 | A6-I/O |
| 45 | I/O | 86 | I/O | 128 | I/O | 4 | I/O |
| 46 | I/O | 87 | I/O | 129 | I/O | 5 | I/O |
| 47 | I/O | 88 | I/O | 130 | I/O | 6 | I/O |
| 48 | I/O | 89 | I/O | 131 | D2-I/O | 7 | I/O |
| 49 | I/O | 90 | I/O | 132 | I/O | 8 | A12-I/O |
| 50 | I/O | 91 | I/O | 133 | I/O | 9 | A7-I/O |
| 51 | I/O | 92 | I/O | 134 | I/O | 10 | I/O |
| 52 | I/O | 93 | I/O | 135 | I/O | 11 | I/O |
| 53 | I/O | 94 | I/O | 136 | I/O | 12 | A11-I/O |
| 54 | I/O | 95 | I/O | 137 | D1-I/O | 13 | A8-I/O |
| 55 | I/O | 96 | I/O | 138 | RDY- BUSY - RCLK -I/O | 14 | I/O |
| 56 | I/O | 97 | I/O | 139 | I/O | 15 | I/O |
| 57 | I/O | 98 | I/O | 140 | I/O | 16 | A10-I/O |
| 58 | I/O | 99 | XTAL2(IN)-I/O | 141 | I/O | 17 | A9-I/O |
| 59 | I/O | 100 | GND | 142 | I/O | 18 | Vcc |
| 60 | I/O | 101 | RESET | | | 19 | GND |
| | | 102 | Vcc | | | | |

Note: Unprogrammed IOBs have a default pull-up. This prevents an undefined pad level for unbonded or unused IOBs.
Programmed outputs are default slew-limited.

ATT3000 Series Field-Programmable Gate Arrays

Table 2j. ATT3000 Family 175-Pin PGA Pinouts

| PGA Pin No. | ATT3090 | PGA Pin No. | ATT3090 | PGA Pin No. | ATT3090 | PGA Pin No. | ATT3090 |
|-------------|------------|-------------|---------------|-------------|-----------------------|-------------|-------------|
| B2 | PWRDWN | D13 | I/O | R14 | DONE- PROG | R3 | D0-DIN-I/O |
| D4 | TCLKIN-I/O | B14 | M1- RDATA | N13 | D7-I/O | N4 | DOUT-I/O |
| B3 | I/O | C14 | GND | T14 | XTAL1(OUT)-BCLKIN-I/O | R2 | CCLK |
| C4 | I/O | B15 | M0-RTRIG | P13 | I/O | P3 | Vcc |
| B4 | I/O | D14 | Vcc | R13 | I/O | N3 | GND |
| A4 | I/O | C15 | M2-I/O | T13 | I/O | P2 | A0- WS -I/O |
| D5 | I/O | E14 | HDC-I/O | N12 | I/O | M3 | A1-CS2-I/O |
| C5 | I/O | B16 | I/O | P12 | D6-I/O | R1 | I/O |
| B5 | I/O | D15 | I/O | R12 | I/O | N2 | I/O |
| A5 | I/O | C16 | I/O | T12 | I/O | P1 | A2-I/O |
| C6 | I/O | D16 | LDC -I/O | P11 | I/O | N1 | A3-I/O |
| D6 | I/O | F14 | I/O | N11 | I/O | L3 | I/O |
| B6 | I/O | E15 | I/O | R11 | I/O | M2 | I/O |
| A6 | I/O | E16 | I/O | T11 | D5-I/O | M1 | A15-I/O |
| B7 | I/O | F15 | I/O | R10 | CS0 -I/O | L2 | A4-I/O |
| C7 | I/O | F16 | I/O | P10 | I/O | L1 | I/O |
| D7 | I/O | G14 | I/O | N10 | I/O | K3 | I/O |
| A7 | I/O | G15 | I/O | T10 | I/O | K2 | A14-I/O |
| A8 | I/O | G16 | I/O | T9 | I/O | K1 | A5-I/O |
| B8 | I/O | H16 | I/O | R9 | D4-I/O | J1 | I/O |
| C8 | I/O | H15 | INIT -I/O | P9 | I/O | J2 | I/O |
| D8 | GND | H14 | Vcc | N9 | Vcc | J3 | GND |
| D9 | Vcc | J14 | GND | N8 | GND | H3 | Vcc |
| C9 | I/O | J15 | I/O | P8 | D3-I/O | H2 | A13-I/O |
| B9 | I/O | J16 | I/O | R8 | CS1 -I/O | H1 | A6-I/O |
| A9 | I/O | K16 | I/O | T8 | I/O | G1 | I/O |
| A10 | I/O | K15 | I/O | T7 | I/O | G2 | I/O |
| D10 | I/O | K14 | I/O | N7 | I/O | G3 | I/O |
| C10 | I/O | L16 | I/O | P7 | I/O | F1 | I/O |
| B10 | I/O | L15 | I/O | R7 | D2-I/O | F2 | A12-I/O |
| A11 | I/O | M16 | I/O | T6 | I/O | E1 | A7-I/O |
| B11 | I/O | M15 | I/O | R6 | I/O | E2 | I/O |
| D11 | I/O | L14 | I/O | N6 | I/O | F3 | I/O |
| C11 | I/O | N16 | I/O | P6 | I/O | D1 | A11-I/O |
| A12 | I/O | P16 | I/O | T5 | I/O | C1 | A8-I/O |
| B12 | I/O | N15 | I/O | R5 | D1-I/O | D2 | I/O |
| C12 | I/O | R16 | I/O | P5 | RDY/ BUSY - RCLK -I/O | B1 | I/O |
| D12 | I/O | M14 | I/O | N5 | I/O | E3 | A10-I/O |
| A13 | I/O | P15 | XTAL2(IN)-I/O | T4 | I/O | C2 | A9-I/O |
| B13 | I/O | N14 | GND | R4 | I/O | D3 | Vcc |
| C13 | I/O | R15 | RESET | P4 | I/O | C3 | GND |
| A14 | I/O | P14 | Vcc | | | | |

Notes: Unprogrammed IOBs have a default pull-up. This prevents an undefined pad level for unbonded or unused IOBs.
Programmed outputs are default slew-limited.

Pins A2, A3, A15, A16, T1, T2, T3, T15, and T16 are not connected. Pin A1 does not exist.

ATT3000 Series Field-Programmable Gate Arrays

Table 2k. ATT3000 Family 208-Pin QFP Pinouts

| QFP Pin No. | ATT3090 | QFP Pin No. | ATT3090 | QFP Pin No. | ATT3090 | QFP Pin No. | ATT3090 |
|----------------|------------|----------------|-----------|----------------|----------------------|----------------|-------------|
| 1 | | 53 | | 105 | | 157 | |
| 2 | GND | 54 | | 106 | Vcc | 158 | |
| 3 | POWERDOWN | 55 | Vcc | 107 | DONE- PG | 159 | |
| 4 | TCLKIN-I/O | 56 | M2-I/O | 108 | | 160 | GND |
| 5 | I/O | 57 | HDC-I/O | 109 | I/O-D7 | 161 | I/O- WS -A0 |
| 6 | I/O | 58 | I/O | 110 | I/O-XTAL-BCLKIN | 162 | I/O-CS2-A1 |
| 7 | I/O | 59 | I/O | 111 | I/O | 163 | I/O |
| 8 | I/O | 60 | I/O | 112 | I/O | 164 | I/O |
| 9 | I/O | 61 | LDC -I/O | 113 | I/O | 165 | I/O-A2 |
| 10 | I/O | 62 | I/O | 114 | I/O | 166 | I/O-A3 |
| 11 | I/O | 63 | I/O | 115 | I/O-D6 | 167 | I/O |
| 12 | I/O | 64 | | 116 | I/O | 168 | I/O |
| 13 | I/O | 65 | | 117 | I/O | 169 | |
| 14 | I/O | 66 | | 118 | I/O | 170 | |
| 15 | | 67 | | 119 | | 171 | |
| 16 | I/O | 68 | I/O | 120 | I/O | 172 | I/O-A15 |
| 17 | I/O | 69 | I/O | 121 | I/O | 173 | I/O-A4 |
| 18 | I/O | 70 | I/O | 122 | I/O-D5 | 174 | I/O |
| 19 | I/O | 71 | I/O | 123 | I/O- CS0 | 175 | I/O |
| 20 | I/O | 72 | | 124 | I/O | 176 | |
| 21 | I/O | 73 | | 125 | I/O | 177 | |
| 22 | I/O | 74 | I/O | 126 | I/O | 178 | I/O-A14 |
| 23 | I/O | 75 | I/O | 127 | I/O | 179 | I/O-A5 |
| 24 | I/O | 76 | I/O | 128 | I/O-D4 | 180 | I/O |
| 25 | GND | 77 | INIT -I/O | 129 | I/O | 181 | I/O |
| 26 | Vcc | 78 | Vcc | 130 | Vcc | 182 | GND |
| 27 | I/O | 79 | GND | 131 | GND | 183 | Vcc |
| 28 | I/O | 80 | I/O | 132 | I/O-D3 | 184 | I/O-A13 |
| 29 | I/O | 81 | I/O | 133 | I/O- CS1 | 185 | I/O-A6 |
| 30 | I/O | 82 | I/O | 134 | I/O | 186 | I/O |
| 31 | I/O | 83 | | 135 | I/O | 187 | I/O |
| 32 | I/O | 84 | | 136 | I/O | 188 | |
| 33 | I/O | 85 | I/O | 137 | I/O | 189 | |
| 34 | I/O | 86 | I/O | 138 | I/O-D2 | 190 | I/O |
| 35 | I/O | 87 | I/O | 139 | I/O | 191 | I/O |
| 36 | I/O | 88 | I/O | 140 | I/O | 192 | I/O-A12 |
| 37 | | 89 | I/O | 141 | I/O | 193 | I/O-A7 |
| 38 | I/O | 90 | | 142 | | 194 | |
| 39 | I/O | 91 | | 143 | I/O | 195 | |
| 40 | I/O | 92 | | 144 | I/O | 196 | |
| 41 | I/O | 93 | I/O | 145 | I/O-D1 | 197 | I/O |
| 42 | I/O | 94 | I/O | 146 | I/O- BUSY /RDY- RCLK | 198 | I/O |
| 43 | I/O | 95 | I/O | 147 | I/O | 199 | I/O-A11 |
| 44 | I/O | 96 | I/O | 148 | I/O | 200 | I/O-A8 |
| 45 | I/O | 97 | I/O | 149 | I/O | 201 | I/O |
| 46 | I/O | 98 | I/O | 150 | I/O | 202 | I/O |
| 47 | I/O | 99 | I/O | 151 | I/O-DIN-D0 | 203 | I/O-A10 |
| 48 | M1- RDATA | 100 | XTAL2-I/O | 152 | I/O-DOUT | 204 | I/O-A9 |
| 49 | GND | 101 | GND | 153 | CCLK | 205 | Vcc |
| 50 | M0-RTRIG | 102 | RESET | 154 | Vcc | 206 | |
| 51 | | 103 | | 155 | | 207 | |
| 52 | | 104 | | 156 | | 208 | |

□ = Preliminary.

Note: Unprogrammed IOBs have a default pull-up. This prevents an undefined pad level for unbonded or unused IOBs.
Programmed outputs are default slew-limited.

PARAMETRICS

Absolute Maximum Ratings

Stresses in excess of the Absolute Maximum Ratings can cause permanent damage to the device. These are absolute stress ratings only. Functional operation of the device is not implied at these or any other conditions in excess of those given in the operational sections of the data sheet. Exposure to Absolute Maximum Ratings for extended periods can adversely affect device reliability.

| Symbol | Parameter | Limit | Units |
|------------------|---|-------------------------------|-------|
| V _{CC} | Supply voltage relative to GND | −0.5 to 7.0 | V |
| V _{IN} | Input voltage with respect to GND | −0.5 to V _{CC} + 0.5 | V |
| V _{TS} | Voltage applied to three-state output | −0.5 to V _{CC} + 0.5 | V |
| T _{STG} | Storage temperature (ambient) | −65 to +150 | °C |
| T _{SOL} | Maximum soldering temperature (10 sec @ 1/16 in.) | +260 | °C |
| T _J | Junction temperature plastic | +125 | °C |
| | Junction temperature ceramic | +150 | °C |

Recommended Operating Conditions

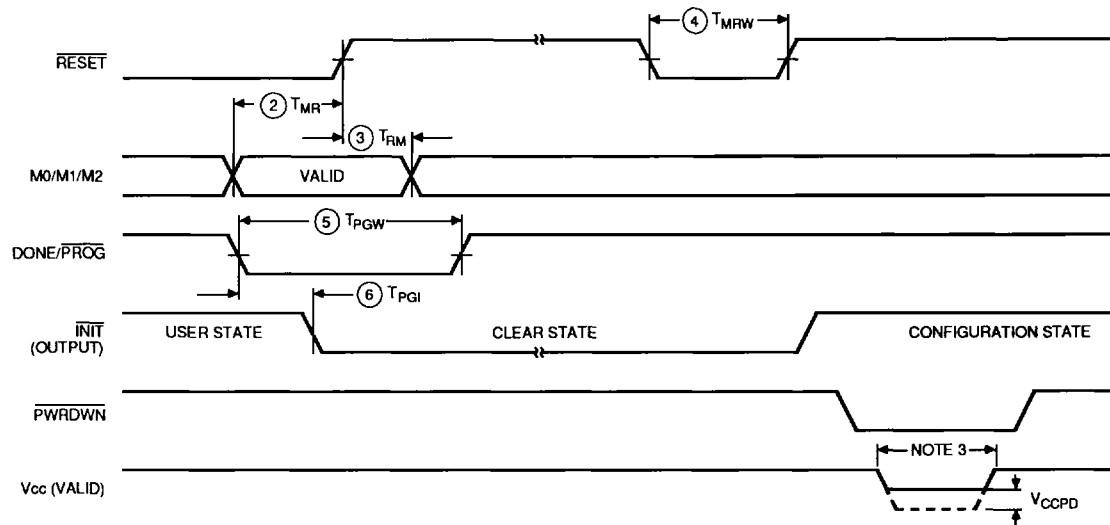
| Symbol | Parameter | | Min | Max | Units |
|------------------|---|------------|------|-----------------|-----------------|
| V _{CC} | Supply voltage relative to GND | Commercial | 4.75 | 5.25 | V |
| | | Industrial | 4.5 | 5.5 | V |
| V _{IHT} | High-level input voltage — TTL configuration | | 2.0 | V _{CC} | V |
| V _{ILT} | Low-level input voltage — TTL configuration | | 0 | 0.8 | V |
| V _{IHC} | High-level input voltage — CMOS configuration | | 70% | 100% | V _{CC} |
| V _{ILC} | Low-level input voltage — CMOS configuration | | 0 | 20% | V _{CC} |
| T _{IN} | Input signal transition time | | | 250 | ns |
| T _A | Ambient Temperature Range | Commercial | 0 | +70 | °C |
| | | Industrial | −40 | +85 | °C |

Electrical Characteristics Over Operating Conditions

| Symbol | Parameter/Conditions | | Min | Max | Units |
|--------|---|------------|------|----------|----------|
| VOH | High-level output voltage (@ IOH = -4.0 mA, VCC min) | Commercial | 3.86 | | V |
| VOL | Low-level output voltage (@ IOL = 4.0 mA, VCC min) | | | 0.32 | V |
| VOH | High-level output voltage (@ IOL = -4.0 mA, VCC min) | Industrial | 3.76 | | V |
| VOL | Low-level output voltage (@ IOL = 4.0 mA, VCC min) | | | 0.37 | V |
| VCCPD | Power-down supply voltage (PWRDWN must be Low) | | 2.3 | | V |
| ICCPD | Power-down supply current (VCC = 5.0 V @ 70 °C; | ATT3020 | | 50 | μA |
| | | ATT3030 | | 80 | μA |
| | | ATT3042 | | 120 | μA |
| | | ATT3064 | | 170 | μA |
| | | ATT3090 | | 250 | μA |
| ICCO | Quiescent FPGA supply current in addition to ICCPD | | | | |
| | Chip thresholds programmed as CMOS levels | | | 500 | μA |
| | Chip thresholds programmed as TTL levels | | | 10 | mA |
| IIL | Leakage Current | | -10 | +10 | μA |
| CIN | Input capacitance, all packages except PGA 175 (sample tested) All Pins except XTL1 and XTL2 XTL1 and XTL2 | | | 10 15 | pf pf |
| | Input capacitance, PGA 175 (sample tested) All Pins except XTL1 and XTL2 XTL1 and XTL2 | | | 15 20 | pf pf |
| IRIN | Pad pull-up (when selected) @ VIN = 0 V (sample tested) | | 0.02 | 0.17 | mA |
| IRLL | Horizontal long line pull-up (when selected) @ logic LOW | | 0.2 | 2.5 | mA |

Note: With no output current loads, no active input or long line pull-up resistors, all package pins at VCC or GND, and the FPGA configured with a MAKEBITS tie option. See FPGA power chart for additional activity-dependent operating component.

GENERAL FPGA SWITCHING CHARACTERISTICS



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| Signal | Description | Speed (4) | | -70 | | -100 | | -125 | | 150 | | Unit |
|------------|--|-----------|-------------------|-----|-----|------|-----|------|-----|-----|-----|------|
| | | Symbol | | Min | Max | Min | Max | Min | Max | Min | Max | |
| RESET (2) | M0, M1, M2 setup time required | 2 | T _{MR} | 1 | | 1 | | 0 | | 0 | | μs |
| | M0, M1, M2 hold time required | 3 | T _{RM} | 1 | | 1 | | 1 | | 1 | | μs |
| | RESET Width (Low) req. for Abort | 4 | T _{MRW} | 6 | | 6 | | 6 | | 6 | | μs |
| DONE/ PROG | Width (Low0 required for Re-config. | 5 | TPGW | 6 | | 6 | | 6 | | 6 | | μs |
| | INIT response after D/ P is pulled Low | 6 | TPGI | | 7 | | 7 | | 7 | | 7 | μs |
| PWRDWN (3) | Powerdown VCC | | V _{CCPD} | 2.3 | | 2.3 | | 2.3 | | 2.3 | | V |

□ = Preliminary.

Notes:

- At power-up, Vcc must rise from 2.0 V to Vcc minimum in less than 25 ms. If this is not possible, configuration can be delayed by holding RESET Low until Vcc has reached 4.0 V. A very long Vcc rise time of >100 ms, or a non-monotonically rising Vcc may require a >1 μs High level on RESET, followed by a >6 μs Low level on RESET and D/P after Vcc has reached 4.0 V.
- RESET timing relative to valid mode lines (M0, M1, M2) is relevant when RESET is used to delay configuration.
- PWRDWN transitions must occur while Vcc > 4.0 V.

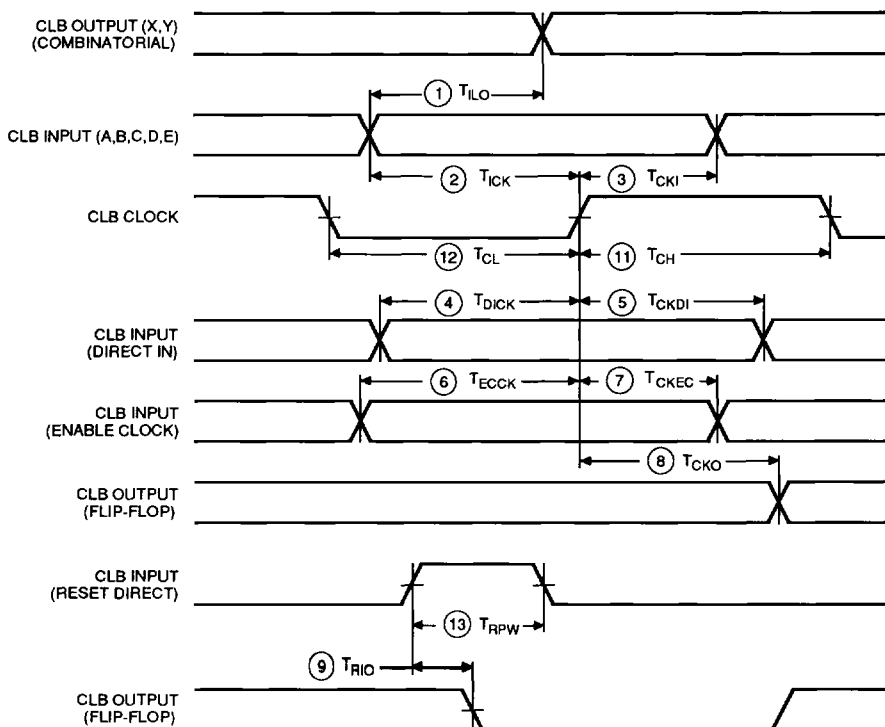
BUFFER (Internal) SWITCHING CHARACTERISTIC GUIDELINES

| | Speed Grade | -70 | -100 | -125 | 150 | Units |
|---|-------------------|-----|------|------|-----|-------|
| Description | Symbol | Max | Max | Max | Max | |
| Global and Alternate Clock Distribution* | | | | | | |
| Either: Normal IOB input pad to clock buffer input | TPID | 8 | 7.5 | 7 | 6.7 | ns |
| Or: Fast (CMOS only) input pad to clock buffer input | TPIDC | 6.5 | 6 | 5.7 | 5.5 | ns |
| TBUF driving a Horizontal Long line (L.L.)* | | | | | | |
| I to L.L. while T is Low (buffer active) | T _{IO} | 5 | 4.7 | 4.5 | 4.3 | ns |
| T↓ to L.L. active and valid with single pull-up resistor | T _{ON} | 11 | 10 | 9 | 8 | ns |
| T↓ to L.L. active and valid with pair of pull-up resistors | T _{ON} | 12 | 11 | 10 | 9 | ns |
| T↑ to L.L. High with single pull-up resistor | T _{PUS} | 24 | 22 | 17 | 16 | ns |
| T↑ to L.L. High with pair of pull-up resistors | T _{PUF} | 17 | 15 | 12 | 11 | ns |
| BIDI | | | | | | |
| Bidirectional buffer delay | T _{BIDI} | 2 | 1.8 | 1.7 | 1.6 | ns |

* Timing is based on the ATT3042; for other devices, see XACT timing calculator.

■ = Preliminary.

CLB SWITCHING CHARACTERISTIC GUIDELINES



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CLB SWITCHING CHARACTERISTIC GUIDELINES (continued)

Testing of the switching characteristic guidelines is modeled after testing specified by MIL-M-38510/605. Devices are 100% functionally tested. Benchmark timing patterns are used to provide correlation to the switching characteristic guideline values. Actual worst-case timing is provided by the *XACT* Timing calculator or Simulation modeling.

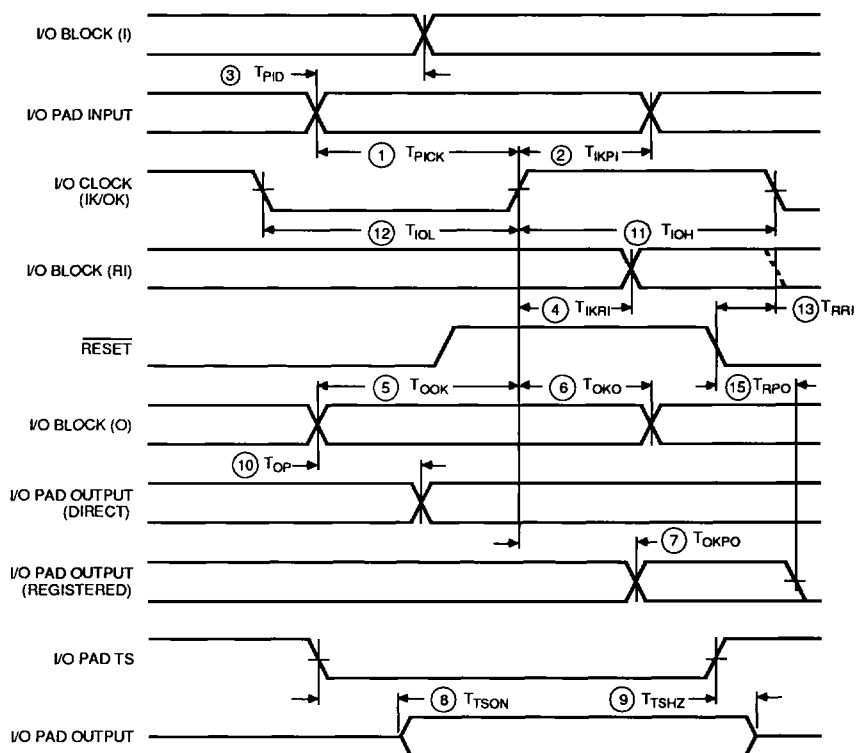
| Description | Speed Grade | | -70 | | -100 | | -125 | | 150 | | Units |
|---|-------------|-------|-----|-----|------|-----|------|-----|-----|-----|-------|
| | Symbol | | Min | Max | Min | Max | Min | Max | Min | Max | |
| Combinatorial Delay Logic Variables a, b, c, d, e, to outputs x, y | 1 | TILO | | 9 | | 7 | | 5.5 | | 4.6 | ns |
| Sequential delay clock k to outputs x, y clock k outputs x, y when Q is returned through function generators F or G to drive x, y | 8 | TCKO | | 6 | | 5 | | 4.5 | | 4 | ns |
| | | TCKOO | | 13 | | 10 | | 8 | | 6.7 | ns |
| Set-up time before clock K Logic Variables a, b, c, d, e Data In di Enable Clock ec Reset Direct inactive rd | 2 | TICK | 8 | | 7 | | 5.5 | | 4.6 | | ns |
| | 4 | TDICK | 5 | | 4 | | 3 | | 2 | | ns |
| | 6 | TECCK | 7 | | 5 | | 4.5 | | 4 | | ns |
| | | TRDCK | 1 | | 1 | | 1 | | 1 | | ns |
| Hold Time after clock k Logic Variables a, b, c, d, e Data In di Enable Clock ec | 3 | TCKI | 0 | | 0 | | 0 | | 0 | | ns |
| | 5 | TCKDI | 4 | | 2 | | 1.5 | | 1.2 | | ns |
| | 7 | TCKEC | 0 | | 0 | | 0 | | 0 | | ns |
| Clock Clock High time* Clock Low time* Max. flip-flop toggle rate* | 11 | TCH | 5 | | 4 | | 3 | | 2.5 | | ns |
| | 12 | TCL | 5 | | 4 | | 3 | | 2.5 | | ns |
| | | FCLK | 70 | | 100 | | 125 | | 150 | | MHz |
| Reset Direct (rd) rd width delay from rd to outputs x, y | 13 | TRPW | 8 | | 7 | | 6 | | 5 | | ns |
| | 9 | TRIO | | 8 | | 7 | | 6 | | 5 | ns |
| Master Reset (MR) MR width delay from MR to outputs x, y | | TMRW | 25 | | 21 | | 20 | | 19 | | ns |
| | | TMRQ | | 23 | | 19 | | 17 | | 17 | ns |

* Timing is based on the ATT3042, for other devices see the *XACT* timing calculation.

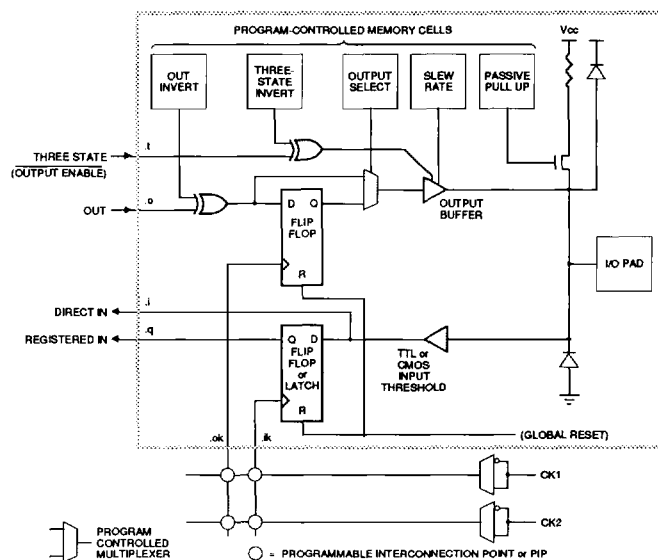
 = Preliminary.

Note: The CLB K to Q output delay (TCKO, #8) of any CLB, plus the shortest possible interconnect delay, is always longer than the Data In hold time requirement (TCKDI, #5) of any CLB on the same die.

IOB SWITCHING CHARACTERISTIC GUIDELINES



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IOB SWITCHING CHARACTERISTIC GUIDELINES (continued)

Testing of the switching characteristic guidelines is modeled after testing specified by MIL-M-38510/605. Devices are 100% functionally tested. Benchmark timing patterns are used to provide correlation to the switching characteristic guideline values. Actual worst-case timing is provided by the XACT Timing calculator or Simulation modeling.

| | Speed Grade | | -70 | | -100 | | -125 | | 150 | | Units |
|---|-------------|-------|-----|-----|------|-----|------|-----|------|-----|-------|
| Description | Symbol | | Min | Max | Min | Max | Min | Max | Min | Max | |
| Propagation Delays (Input) | | | | | | | | | | | |
| Pad to Direct In (i) | 3 | TPID | | 6 | | 4 | | 3 | | 2.8 | ns |
| Pad to Registered In (q) with latch transparent | | TPTG | | 21 | | 17 | | 16 | | 15 | ns |
| Clock (ik) to Registered In (q) | 4 | TIKRI | | 5.5 | | 4 | | 3 | | 2.8 | ns |
| Set-up Time (Input) | | | | | | | | | | | |
| Pad to Clock (ik) set-up time | 1 | TPICK | 20 | | 17 | | 16 | | 14.5 | | ns |
| Propagation Delays (Output) | | | | | | | | | | | |
| Clock (ok) to Pad (fast) | 7 | TOKPO | | 13 | | 10 | | 9 | | 7 | ns |
| same (slew-rate limited) | 7 | TOKPO | | 33 | | 27 | | 24 | | 22 | ns |
| Output (o) to Pad (fast) | 10 | TOPF | | 9 | | 6 | | 5 | | 4.5 | ns |
| same (slew-rate limited) | 10 | TOPS | | 29 | | 23 | | 20 | | 15 | ns |
| 3-state to Pad begin hi-Z (fast) | 9 | TTSHZ | | 8 | | 8 | | 7 | | 7 | ns |
| same (slew-rate limited) | 9 | TTSHZ | | 28 | | 25 | | 24 | | 22 | ns |
| 3-state to Pad and valid (fast) | 8 | TTSON | | 14 | | 12 | | 11 | | 11 | ns |
| same (slew-rate limited) | 8 | TTSON | | 34 | | 29 | | 27 | | 26 | ns |
| Set-up and Hold Times (Output) | | | | | | | | | | | |
| Output (o) to clock (ok) set-up time | 5 | TOCK | 10 | | 9 | | 8 | | 7 | | ns |
| Output (o) to clock (ok) hold time | 6 | TOKO | 0 | | 0 | | 0 | | 0 | | ns |
| Clock | | | | | | | | | | | |
| Clock High time* | 11 | TCH | 5 | | 4 | | 3 | | 2.5 | | ns |
| Clock Low time* | 12 | TCL | 5 | | 4 | | 3 | | 2.5 | | ns |
| Max. flip-flop toggle rate | | FCLK | 0 | | 100 | | 125 | | 150 | | MHz |
| Master Reset Delays | | | | | | | | | | | |
| RESET Pad to Registered In (q) | 13 | TRRI | | 25 | | 24 | | 23 | | 20 | ns |
| RESET Pad to output pad (fast) | 15 | TRPO | | 35 | | 33 | | 29 | | 25 | ns |
| (slew-rate limited) | 15 | TRPO | | 53 | | 45 | | 42 | | 40 | ns |

■ = Preliminary.

Notes:

Timing is measured at pin threshold, with 50 pF external capacitive loads (incl. test fixture).

Typical fast mode output rise/fall times are 2 ns and will increase approximately 2%/pF of additional load.

Typical slew-rate limited output rise/fall times are approximately 4 times longer.

A maximum total external capacitive load for simultaneous fast mode switching in the same direction is 200 pF per power/ground pin pair. For slew-rate limited outputs this total is 4 times larger.

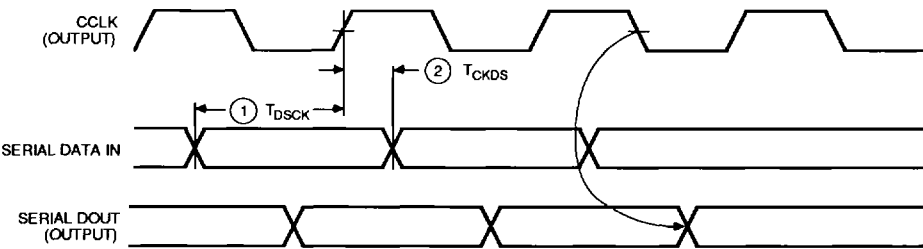
Voltage levels of unused (bonded and unbonded) pads must be valid logic levels. Each can be configured with the internal pull-up resistor or alternatively configured as a driven output or driven from an external source.

Input pad set up time is specified with respect to the internal clock (.ik).

In order to calculate system set up time, subtract clock delay (pad to ik) from the input pad set up time value.

Input pad holdtime with respect to the internal clock (ik) is negative. This means that pad level changes immediately before the internal clock edge (ik) will not be recognized.

MASTER SERIAL MODE SWITCHING CHARACTERISTICS GUIDELINES



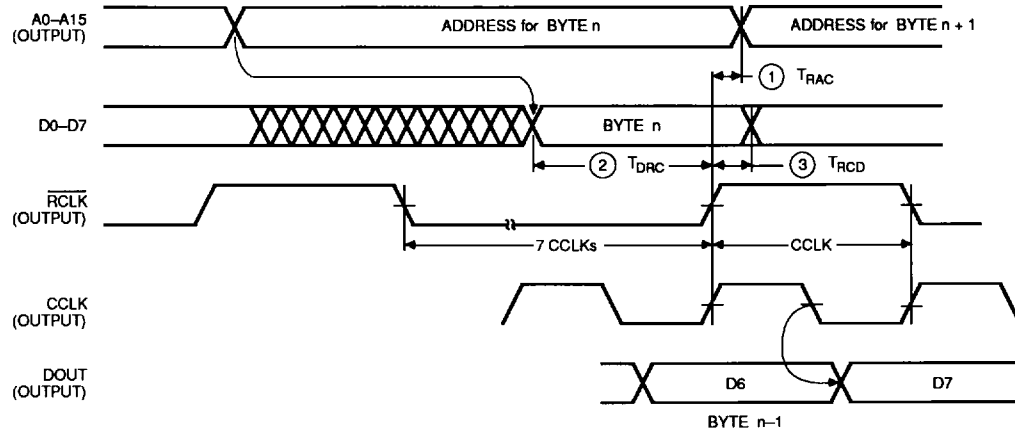
2271 31

| | | Speed | | -70 | | -100 | | -125 | | 150 | | Unit |
|--------|---------------|--------|-------------------|-----|-----|------|-----|------|-----|-----|-----|------|
| Signal | Description | Symbol | | Min | Max | Min | Max | Min | Max | Min | Max | |
| CCLK | Data In setup | 1 | T _{DSCK} | 60 | | 60 | | 60 | | 60 | | ns |
| | Data in hold | 2 | T _{CKDS} | 0 | | 0 | | 0 | | 0 | | ns |

- Notes:
1. At power-up, V_{cc} must rise from 2.0 V to V_{cc} minimum in less than 25 ms. If this is not possible, configuration can be delayed by holding RESET Low until V_{cc} has reached 4.0 V. A very long V_{cc} rise time of ≥ 100 ms, or a non-monotonically rising V_{cc} may require a >1 μ s High level on RESET, followed by a >6 μ s Low level on RESET and D/P after V_{cc} has reached 4.0 V.
 2. Configuration can be controlled by holding RESET Low with or until after the INIT of all daisy-chain slave-mode devices is High.
 3. Master-serial-mode timing is based on slave-mode testing.

MASTER PARALLEL MODE PROGRAMMING SWITCHING CHARACTERISTIC GUIDELINES

Testing of the switching characteristic guidelines is modeled after testing specified by MIL-M-38510/605. Devices are 100% functionally tested. Benchmark timing patterns are used to provide correlation to the switching characteristic guideline values. Actual worst-case timing is provided by the *XACT* Timing calculator or Simulation modeling.



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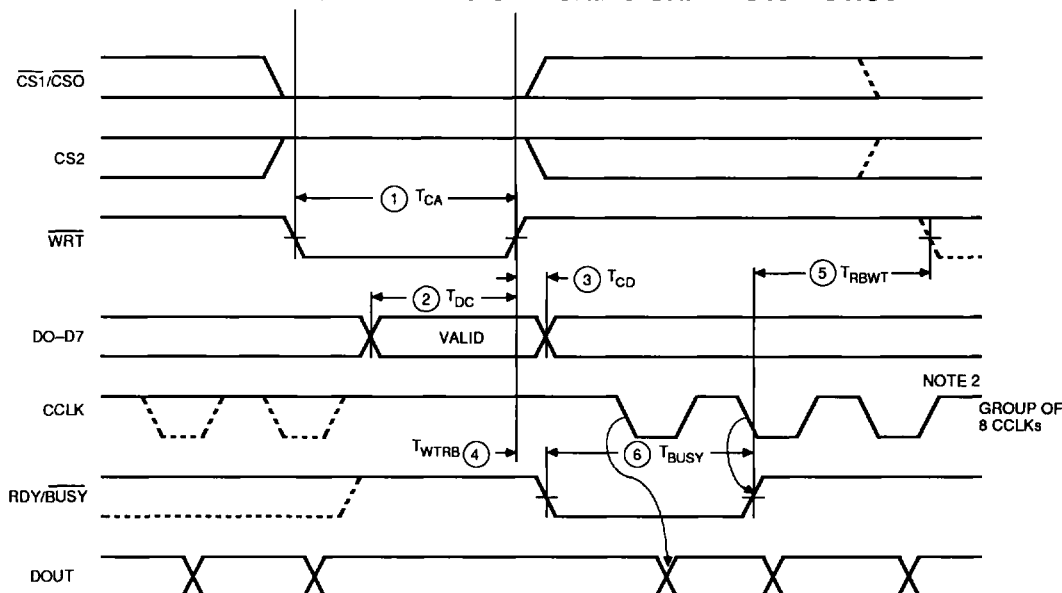
Note: This timing diagram shows that the EPROM requirements are extremely relaxed: EPROM access time can be longer than 4000 ns. EPROM data output has no hold time requirements.

| Signal | Description | Speed | | -70 | | -100 | | -125 | | 150 | | Unit |
|--------|------------------|--------|------|-----|-----|------|-----|------|-----|-----|-----|------|
| | | Symbol | | Min | Max | Min | Max | Min | Max | Min | Max | |
| RCLK | To address valid | 1 | TRAC | 0 | 200 | 0 | 200 | 0 | 200 | 0 | 200 | ns |
| | To data setup | 2 | TDRC | 60 | | 60 | | 60 | | 60 | | ns |
| | To data hold | 3 | TRCD | 0 | | 0 | | 0 | | 0 | | ns |
| | RCLK high | | TRCH | 600 | | 600 | | 600 | | 600 | | ns |
| | RCLK low | | TRCL | 4.0 | | 4.0 | | 4.0 | | 4.0 | | μs |

Notes:

- At power-up, V_{CC} must rise from 2.0 V to V_{CC} minimum in less than 25 ms. If this is not possible, configuration can be delayed by holding RESET Low until V_{CC} has reached 4.0 V. A very long V_{CC} rise time of >100 ms, or a non-monotonically rising V_{CC} may require a >1 μs High level on RESET, followed by a >6 μs Low level on RESET and D/P after V_{CC} has reached 4.0 V.
- Configuration can be controlled by holding RESET Low with or until after the INIT of all daisy-chain slave-mode devices is High.

PERIPHERAL MODE PROGRAMMING SWITCHING CHARACTERISTICS



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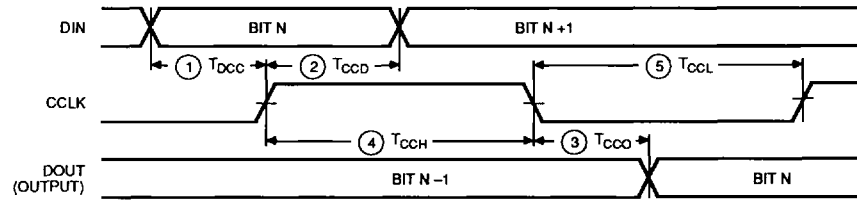
Note: This timing diagram shows very relaxed requirements: Data need not be held beyond the rising edge of WS. BUSY will go active within 60 ns after the end of WS. BUSY will stay active for several microseconds. WS may be asserted immediately after the end of BUSY.

| Signal | Description | Speed | | -70 | | -100 | | -125 | | 150 | | Unit |
|--------|---|--------|------------|-----|-----|------|-----|------|-----|-----|-----|--------------|
| | | Symbol | | Min | Max | Min | Max | Min | Max | Min | Max | |
| Write | Effective write time required ($CS0 \times CS1 \times CS2 \times WS$) | 1 | T_{CA} | 100 | | 100 | | 100 | | 100 | | ns |
| | DIN setup time required | 2 | T_{DC} | 60 | | 60 | | 60 | | 60 | | ns |
| | DIN hold time required | 3 | T_{CD} | 0 | | 0 | | 0 | | 0 | | ns |
| | RDY/ \overline{BUSY} delay after end of \overline{WS} | 4 | T_{WTRB} | | 60 | | 60 | | 60 | | 60 | ns |
| RDY | Earliest next \overline{WS} after end of \overline{BUSY} | 5 | T_{RBWT} | 0 | | 0 | | 0 | | 0 | | ns |
| | \overline{BUSY} Low time generated | 6 | T_{BUSY} | 2 | 9 | 2 | 9 | 2 | 9 | 2 | 9 | CCLK Periods |

Notes:

- At power-up, V_{CC} must rise from 2.0 V to V_{CC} minimum in less than 25 ms. If this is not possible, configuration can be delayed by holding RESET Low until V_{CC} has reached 4.0 V. A very long V_{CC} rise time of >100 ms, or a non-monotonically rising V_{CC} may require a >1 μ s High level on RESET, followed by a >6 μ s Low level on RESET and D/P after V_{CC} has reached 4.0 V.
- Configuration must be delayed until the INIT of all LCAs is High.
- Time from end of WS to CCLK cycle for the new byte of data depends on completion of previous byte processing and the phase of the internal timing generator for CCLK.
- CCLK and DOUT timing is tested in slave mode.

SLAVE MODE PROGRAMMING SWITCHING CHARACTERISTICS



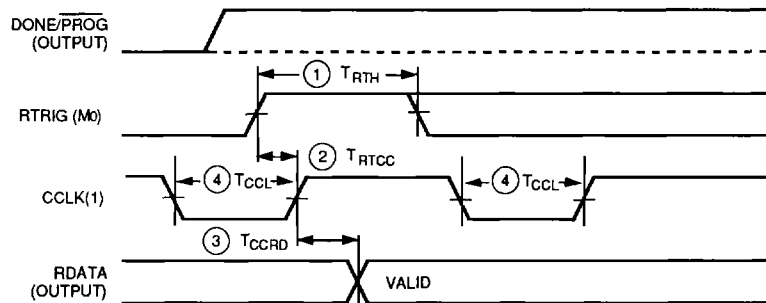
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| | | Speed | | -70 | | -100 | | -125 | | 150 | | Unit |
|--------|-------------|--------|------|------|-----|------|-----|------|-----|------|-----|------|
| Signal | Description | Symbol | | Min | Max | Min | Max | Min | Max | Min | Max | |
| CCLK | To DOUT | 3 | Tcco | | 100 | | 100 | | 100 | | 100 | ns |
| | DIN setup | 1 | Tdcc | 60 | | 60 | | 60 | | 60 | | ns |
| | DIN hold | 2 | Tccd | 0 | | 0 | | 0 | | 0 | | ns |
| | High time | 4 | Tcch | 0.05 | | 0.05 | | 0.05 | | 0.05 | | μs |
| | Low time | 5 | Tccl | 0.05 | 5.0 | 0.05 | 5.0 | 0.05 | 5.0 | 0.05 | 5.0 | μs |
| | Frequency | | Fcc | | 10 | | 10 | | 10 | | 10 | MHz |

Notes:

1. The max limit of CCLK Low time is caused by dynamic circuitry inside the LCA device.
2. Configuration must be delayed until the INIT of all LCAs is High.
3. At power-up, V_{cc} must rise from 2.0 V to V_{cc} minimum in less than 25 ms. If this is not possible, configuration can be delayed by holding RESET Low until V_{cc} has reached 4.0 V. A very long V_{cc} rise time of ≥ 100 ms, or a non-monotonically rising V_{cc} may require a >1 μs High level on RESET, followed by a >6 μs Low level on RESET and D/P after V_{cc} has reached 4.0 V.

PROGRAM READBACK SWITCHING CHARACTERISTICS



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| | | Speed | | -70 | | -100 | | -125 | | 150 | | Unit |
|--------|-------------|--------|-------|-----|-----|------|-----|------|-----|-----|-----|------|
| Signal | Description | Symbol | | Min | Max | Min | Max | Min | Max | Min | Max | |
| RTRIG | RTRIG high | 1 | TRTH | 250 | | 250 | | 250 | | 250 | | ns |
| CCLK | RTRIG setup | 2 | TRTCC | 200 | | 200 | | 200 | | 200 | | ns |
| | RDATA delay | 3 | TCCRD | | 100 | | 100 | | 100 | | 100 | ns |
| | High Time | 5 | TCCH | 0.5 | | 0.5 | | 0.5 | | 0.5 | | μs |
| | Low time | 4 | TCCL | 0.5 | 5 | 0.5 | 5 | 0.5 | 5 | 0.5 | 5 | μs |

Notes:

1. During Readback, CCLK frequency may not exceed 1 MHz.
2. RETRIG (M0 positive transition) shall not be done until after one clock following active I/O pins.
3. Readback should not be initiated until configuration is complete.